











DS90UB913Q-Q1, DS90UB914Q-Q1

ZHCSDZ6D - JULY 2012 - REVISED JULY 2015

DS90UB91xQ-Q1 具有双向控制通道的 10MHz 至 100MHz、10 位和 12 位直流均衡 FPD-Link III 串行器和解串器

1 特性

- 10MHz 至 100MHz 输入像素时钟支持
- 单个差分对互连
- 可编程的数据有效载荷:
 - 10 位有效载荷, 高达 100MHz
 - 12 位有效载荷, 高达 75MHz
- 连续低延迟双向控制接口通道,支持 I²C,频率达 400kHz
- 2:1 多路复用器,可在两个输入成像器之间进行选择
- 具有直流均衡编码的嵌入式时钟,支持交流耦合互连
- 能够驱动长达 25 米的屏蔽双绞线
- 接收均衡器自动适应电缆损耗的变化
- 串行器和解串器上均提供有 4 个专用通用输入/输出引脚 (GPIO)
- LOCK 输出报告引脚和 AT-SPEED BIST (全速内置自检)诊断特性,可验证链路完整性
- 串行器上提供 1.8V、2.8V 或 3.3V 兼容并行输入
- 1.8V 单电源
- 符合 ISO 10605 和 IEC 61000-4-2 静电放电 (ESD) 标准
- 汽车级产品:符合 AEC-Q100 2 级要求
- 温度范围: -40°C 至 +105°C
- 小尺寸串行器 (5mm × 5mm)
- 解串器上提供 EMI/EMC 缓解功能
 - 可编程扩频 (SSCG) 输出

- 接收器交错输出

2 应用

- 前置摄像头或后置摄像头,实现碰撞缓解
- 停车辅助系统环视

3 说明

DS90UB91xQ-Q1 芯片组提供一个具有高速正向通道和双向控制通道的 FPD-Link III 接口,用来实现单一差分对上的数据传输。 DS90UB91xQ-Q1 芯片组的高速正向通道和双向控制通道数据路径上均包含差分信令。串行器和解串器对主要用于电子控制单元 (ECU) 中成像器与视频处理器的连接。 该芯片组非常适用于驱动需要高达 12 位像素深度、2 个同步信号以及双向控制通道总线的视频数据。

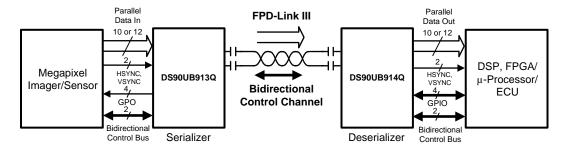
解串器上有一个多路复用器,可用于在两个输入成像器之间进行选择。解串器只能激活一个输入成像器。 主视频传输将 10 位和 12 位数据转换为单条高速串行数据流,另外一个独立的低延迟双向控制通道传输负责接收来自 I²C 端口的控制信息,与视频消隐期无关。

器件信息(1)

器件型号	封装	封装尺寸 (标称值)
DS90UB913Q-Q1	WQFN (32)	5.00mm x 5.00mm
DS90UB914Q-Q1	WQFN (48)	7.00mm x 7.00mm

(1) 要了解所有可用封装,请见数据表末尾的可订购产品附录。

典型应用电路





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4 修订历史记录

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.



5 说明(续)

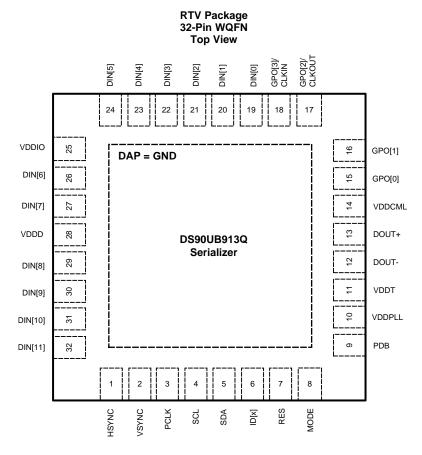
凭借德州仪器 (TI) 的嵌入式时钟技术,可在单一差分对上进行透明的全双工通信,两个方向上运载不对称的双向控制通道信息。 这种单一串行数据流通过消除并行数据与时钟路径间的偏差,简化了印刷电路板 (PCB) 走线和电缆上的宽数据总线传输。 这样,通过限制路径的宽度,大大节省了系统成本,相应地减少了 PCB 层数、电缆宽度以及连接器尺寸和引脚数量。 此外,解串器输入还提供自适应均衡功能来补偿较长距离介质上的损耗。 内部直流均衡编码和解码被用来支持交流耦合互连。 此串化器采用 32 引脚超薄型四方扁平无引线 (WQFN) 封装,而解串器采用 48 引脚 WQFN 封装。

6 器件比较表

器件编号	FPD-III 功能	封装	传输介质	PCLK 频率
DS90UB913Q-Q1	串行器	32 引脚 RTV (WQFN)	STP	10MHz 至 100MHz
DS90UB913A-Q1	串行器	32 引脚 RTV (WQFN)	同轴或屏蔽双绞线 (STP)	25MHz 至 100MHz
DS90UB914Q-Q1	解串器	48 引脚 RHS (WQFN)	STP	10MHz 至 100MHz
DS90UB914A-Q1	解串器	48 引脚 RHS (WQFN)	同轴或 STP	25MHz 至 100MHz



7 Pin Configuration and Functions



DS90UB913Q-Q1 Serializer Pin Functions

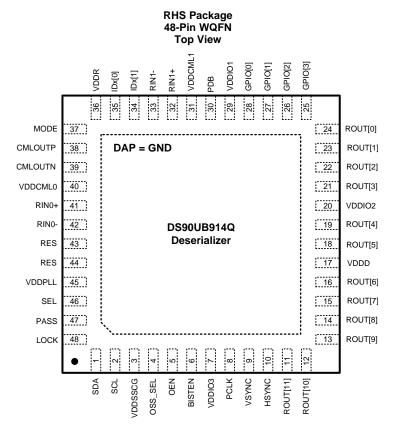
PIN		1/0	DESCRIPTION		
NAME	NO.	1/0	DESCRIPTION		
LVCMOS P	ARALLEL INTERF	ACE			
DIN[0:11]	19, 20, 21, 22, 23, 24, 26, 27, 29, 30, 31, 32	Inputs, LVCMOS with pulldown	Parallel data inputs		
HSYNC	1	Inputs, LVCMOS with pulldown	Horizontal SYNC input		
PCLK	3	Input, LVCMOS with pulldown	Pixel clock input pin Strobe edge set by TRFB control register.		
VSYNC	2	Inputs, LVCMOS with pulldown	Vertical SYNC input		



DS90UB913Q-Q1 Serializer Pin Functions (continued)

PIN NAME NO.		1/0	DESCRIPTION		
		I/O			
GENERAL-	PURPOSE OUTPU	T (GPO)			
GPO[1:0]	16, 15	Output, LVCMOS	General-purpose output pins can be configured as outputs; used to control and respond to various commands. GPO[0:1] can be configured to be the outputs for input signals coming from GPIO[0:1] pins on the deserializer or can be configured to be outputs of the local register on the serializer.		
GPO[2]/ CLKOUT	17	Output, LVCMOS	GPO2 pin can be configured to be the output for input signal coming from the GPIO2 pin on the deserializer or can be configured to be the output of the local register on the serializer. It can also be configured to be the output clock pin when the DS90UB913Q-Q1 device is used in the External Oscillator mode. See <i>Applications Information</i> for a detailed description of the DS90UB91xQ-Q1 chipsets working with the external oscillator.		
GPO[3]/ CLKIN	18	Input/Output, LVCMOS	GPO3 can be configured to be the output for input signals coming from the GPIO3 pin on the deserializer or can be configured to be the output of the local register setting on the serializer. It can also be configured to be the input clock pin when the DS90UB913Q-Q1 serializer is working with an external oscillator. See <i>Applications Information</i> section for a detailed description of the DS90UB91xQ-Q1 chipsets working with an external oscillator.		
BIDIRECTION	ONAL CONTROL B	US - I ² C COMPAT	IBLE		
SCL	4	Input/Output, Open-Drain	Clock line for the bidirectional control bus communication SCL requires an external pullup resistor to V _{DDIO} .		
SDA	5	Input/Output, Open-Drain	Data line for the bidirectional control bus communication SDA requires an external pullup resistor to V _{DDIO} .		
MODE	8	Input, LVCMOS with pulldown	Device mode select Resistor to Ground and 10-kΩ pullup to 1.8-V rail. MODE pin on the serializer can be used to select whether the system is running off the PCLK from the imager or an external oscillator. See details in Table 3.		
ID[x]	6	Input, analog	Device ID address select The ID[x] pin on the serializer is used to assign the I 2 C device address. Resistor to Ground and 10-kΩ pullup to 1.8-V rail. See Table 1.		
CONTROL	AND CONFIGURAT	ΓΙΟΝ			
PDB	9	Input, LVCMOS with pulldown	Power down Mode Input Pin PDB = H, serializer is enabled and is ON. PDB = L, Serailizer is in power-down mode. When the serializer is in power-down, the PLL is shutdown, and IDD is minimized. Programmed control register data are NOT retained and reset to default values		
RES	7	Input, LVCMOS with pulldown	Reserved This pin MUST be tied LOW.		
FPD-Link II	INTERFACE				
DOUT+	13	Input/Output, CML	Noninverting differential output, bidirectional control channel input. The interconnect must be AC-coupled with a 100-nF capacitor.		
DOUT-	12	Input/Output, CML	Inverting differential output, bidirectional control channel input. The interconnect must be AC-coupled with a 100-nF capacitor.		
POWER AN	ID GROUND				
VDDPLL	10	Power, Analog	PLL Power, 1.8 V ±5%		
VDDT	11	Power, Analog	Tx Analog Power, 1.8 V ±5%		
VDDCML	14	Power, Analog	CML and bidirectional channel driver power, 1.8 V ±5%		
VDDD	28	Power, Digital	Digital power, 1.8 V ±5%		
VDDIO	25	Power, Digital	Power for I/O stage. The single-ended inputs and SDA, SCL are powered from V_{DDIO} . V_{DDIO} can be connected to a 1.8 V ±5% or 2.8 V ±10% or 3.3 V ±10%		
VSS	DAP	Ground, DAP	DAP must be grounded. DAP is the large metal contact at the bottom side, located at the center of the WQFN package. Connected to the ground plane (GND) with at least 9 vias.		





DS90UB914Q-Q1 Deserializer Pin Functions

PIN NAME NO.		1/0	DESCRIPTION				
		I/O					
LVCMOS PARA	VCMOS PARALLEL INTERFACE						
ROUT[11:0]	11, 12, 13, 14, 15, 16, 18, 19, 21, 22, 23, 24	Outputs, LVCMOS	Parallel data outputs				
HSYNC	10	Output, LVCMOS	Horizontal SYNC output				
PCLK	8	Output, LVCMOS	Pixel clock output pin Strobe edge set by RRFB control register				
VSYNC	9	Output, LVCMOS	Vertical SYNC output				
GENERAL-PUR	RPOSE INPUT/OUTPU	T (GPIO)					
GPIO[1:0]	27, 28	Digital Input/Output, LVCMOS	General-purpose input/output pins can be used to control and respond to various commands. They may be configured to be the input signals for the corresponding GPOs on the serializer or they may be configured to be outputs to follow local register settings.				
GPIO[3:2]	25, 26	Digital Input/Output LVCMOS	General-purpose input/output pins GPO[2:3] can be configured to be input signals for GPOs on the serializer. In addition they can also be configured to be outputs to follow the local register settings. When the SerDes chipsets are working with an external oscillator, these pins can be configured only to be outputs to follow the local register settings.				



DS90UB914Q-Q1 Deserializer Pin Functions (continued)

PIN		1/0	DESCRIPTION		
NAME	NO.	I/O	DESCRIPTION		
BIDIRECTIONA	AL CONTROL BUS - 12	C COMPATIBLE			
SCL	2	Input/Output, Open-Drain	Clock line for the bidirectional control bus communication SCL requires an external pullup resistor to V _{DDIO} .		
SDA	1	Input/Output, Open-Drain	Data line for bidirectional control bus communication SDA requires an external pullup resistor to V _{DDIO} .		
MODE	37	Input, LVCMOS with pullup	Device mode select pin Resistor-to-Ground and 10-kΩ pullup to 1.8-V rail. The MODE pin on the deserializer can be used to configure the serializer and deserializer to work in different input PCLK range. See details in Table 8. 12-bit low-frequency mode (10- to 50-MHz operation): In this mode, the serializer and deserializer can accept up to 12 bits DATA+2 SYNC. Input PCLK range is from 10 MHz to 50 MHz. 12-bit high-frequency mode (15- to 75-MHz operation): In this mode, the serializer and deserializer can accept up to 12 bits DATA + 2 SYNC. Input PCLK range is from 15 MHz to 75 MHz. 10-bit mode (20- to 100-MHz operation): In this mode, the serializer and deserializer can accept up to 10 bits DATA + 2 SYNC. Input PCLK frequency can range from 20 MHz to 100 MHz. Refer to Table 4 in the <i>Applications Information</i> section on how to configure the MODE pin on the deserializer.		
IDx[0:1]	35, 34	Input, analog	The IDx[0] and IDx[1] pins on the deserializer are used to assign the I 2 C device address. Resistor-to-Ground and 10-k Ω pullup to 1.8-V rail. See Table 2 Input pin to select the slave device address. Input is connect to external resistor divider to set programmable Device ID address.		
CONTROL ANI	D CONFIGURATION				
PDB	30	Input, LVCMOS with pulldown	Power-down mode input pin PDB = H, deserializer is enabled and is ON. PDB = L, deserializer is in sleep (power-down mode). When the deserializer is in sleep, programmed control register data are NOT retained and reset to default values.		
LOCK	48	Output, LVCMOS	LOCK status output pin LOCK = H, PLL is Locked, outputs are active LOCK = L, PLL is unlocked, ROUT and PCLK output states are controlled by OSS_SEL control register. May be used as link status.		
BISTEN	6	Input LVCMOS with pulldown	BIST enable pin BISTEN=H, BIST mode enabled BISTEN=L, BIST mode is disabled		
PASS	47	Output, LVCOMS	PASS output pin for BIST mode. PASS = H, ERROR FREE transmission PASS = L, one or more errors were detected in the received payload. See Built-In Self Test section for more information. Leave open if unused. Route to test point (pad) recommended.		
OEN	5	Input LVCMOS with pulldown	Output enable input Refer to Table 5		
OSS_SEL	4	Input LVCMOS with pulldown	Output sleep state select pin Refer to Table 5		
SEL	46	Input LVCMOS with pulldown	MUX select line SEL = L, RIN0± input. This selects input A as the active channel on the deserializer. SEL = H, RIN1± input. This selects input B as the active channel on the deserializer.		



DS90UB914Q-Q1 Deserializer Pin Functions (continued)

PIN NAME NO.		1/0	DESCRIPTION		
		I/O			
FPD-LINK III IN	TERFACE				
RIN0+	41	Input/Output, CML	Noninverting differential input, bidirectional control channel. The IO must be AC coupled with a 100-nF capacitor		
RIN0-	42	Input/Output, CML	Inverting differential input, bidirectional control channel. The IO must be AC coupled with a 100-nF capacitor		
RIN1+	32	Input/Output, CML	Noninverting differential input, bidirectional control channel. The IO must be AC coupled with a 100-nF capacitor		
RIN1-	33	Input/Output, CML	Inverting differential input, bidirectional control channel. The IO must be AC coupled with a 100-nF capacitor		
RES	43, 44	_	Reserved; This pin must always be tied low.		
CMLOUTP/N	LOUTP/N 38, 39 — Route to test point or leave open if unused		Route to test point or leave open if unused		
POWER AND G	ROUND				
VDDIO1/2/3	29, 20, 7	Power, Digital	LVCMOS I/O buffer power, The single-ended outputs and control input are powered from V_{DDIO} . V_{DDIO} can be connected to a 1.8 V ±5% or 3.3 V ±10%		
VDDD	17	Power, Digital	Digital core power, 1.8 V ±5%		
VDDSSCG	3	Power, Analog	SSCG PLL power, 1.8 V ±5%		
VDDR	36	Power, Analog	RX analog power, 1.8 V ±5%		
VDDCML0/1	40, 31	Power, Analog	CML and bidirectional control channel drive power, 1.8 V±5%		
VDDPLL	45	Power, Analog	PLL Power, 1.8 V ±5%		
VSS	DAP	Ground, DAP	DAP must be grounded. DAP is the large metal contact at the bottom side, located at the center of the WQFN package. Connected to the ground plane (GND) with at least 16 vias.		



Specifications

8.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1) (2) (3)

	MIN	MAX	UNIT
Supply voltage – V _{DDn} (1.8 V)	-0.3	2.5	V
Supply voltage – V _{DDIO}	-0.3	4.0	V
LVCMOS input voltage	-0.3	VDDIO + 0.3	V
CML driver I/O voltage (V _{DD})	-0.3	V _{DD} + 0.3	V
CML receiver I/O voltage (V _{DD})	-0.3	V _{DD} + 0.3	V
Junction temperature		150	°C
Maximum package power dissipation capacity package		1/θ _{JA} above +25°	°C/W
Air discharge (DOUT+, DOUT-, RIN+, RIN-)	-25	25	kV
Contact discharge (DOUT+, DOUT-, RIN+, RIN-)	-7	7	kV
Storage temperature T _{stg}	-65	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

8.2 ESD Ratings

				VALUE	UNIT
		Human body mode	el (HBM), per AEC Q100-002 ⁽¹⁾	±8000	
		Charged-device mo	odel (CDM), per AEC Q100-011	±1000	
		Machine model (M	Machine model (MM) ±25	±250	
V _(ESD)	Electrostatic discharge	IEC 61000-4-2 ⁽²⁾	Air Discharge (DOUT+, DOUT-, RIN+, RIN-)	≥±25 000	V
	alsonarge	IEC 61000-4-2(-/	Contact Discharge (DOUT+, DOUT-, RIN+, RIN-)	≥±7000	
		ISO10605 ⁽³⁾⁽⁴⁾	Air Discharge	≥±15 000	
		13010605	Contact Discharge	≥±8000	

AEC Q100-002 indicates HBM stressing is done in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

8.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT	
Supply voltage (V _{DDn})	upply voltage (V _{DDn})		1.8	1.89	V	
LVCMOS supply voltage	e (V _{DDIO}) OR	1.71	1.8	1.89		
LVCMOS supply voltage	e (V _{DDIO}) OR	3.0	3.3	3.6	V	
LVCMOS supply voltage (V _{DDIO}) only serializer		2.52	2.8	3.08		
	V _{DDn} (1.8 V)			25	mVp-p	
Supply noise ⁽¹⁾	V _{DDIO} (1.8 V)			25		
	V _{DDIO} (3.3 V)			50		
Operating free-air tempe	g free-air temperature (T _A) –40 25 105		°C			
PCLK clock frequency		10		100	MHz	

Supply noise testing was done with minimum capacitors (as shown on Figure 49 and Figure 48) on the PCB. A sinusoidal signal is AC coupled to the VDDn (1.8-V) supply with amplitude = 25 mVp-p measured at the device VDDn pins. Bit error rate testing of input to the serializer and output of the deserializer with 10 meter cable shows no error when the noise frequency on the serializer is less than 1 MHz. The deserializer on the other hand shows no error when the noise frequency is less than 750 kHz.

If Military/Aerospace specified devices are required, contact the Texas Instruments Sales Office/ Distributors for availability and specifications.

For soldering specifications: see product folder at www.ti.com and SNOA549.

 $R_D = 330 \ \Omega, \ C_S = 150 \ pF$ $R_D = 330 \ \Omega, \ C_S = 150 \ / \ 330 \ pF$ $R_D = 2 \ K\Omega, \ C_S = 150 \ / \ 330 \ pF$



8.4 Thermal Information

		DS90UB913Q-Q1	DS90UB914Q-Q1	
	THERMAL METRIC ⁽¹⁾	RTV (WQFN)	RHS (WQFN)	UNIT
		32 PINS	48 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	38.4	26.9	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	6.9	4.4	°C/W

⁽¹⁾ For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report, SPRA953.

8.5 Electrical Characteristics

	PARAMETER	TEST CO	ONDITIONS	MIN	TYP	MAX	UNIT	
LVCM OUTP		NS 3.3V I/O (SERIALIZER	NIPUTS, DESERIALIZER	OUTPUTS, GPI, G	SPO, CONTR	OL INPUTS	AND	
V_{IH}	High level input voltage	V _{IN} = 3 V to 3.6 V		2		V_{IN}	V	
V_{IL}	Low level input voltage	V _{IN} = 3 V to 3.6 V		GND		0.8	V	
I _{IN}	Input current	$V_{IN} = 0 \text{ V or } 3.6 \text{ V, } V_{IN} =$	= 3 V to 3.6 V	-20	±1	20	μΑ	
V _{OH}	High level output voltage	$V_{DDIO} = 3 \text{ V to } 3.6 \text{ V}, I_{OI}$	2.4		V_{DDIO}	V		
V_{OL}	Low level output voltage	$V_{DDIO} = 3 \text{ V to } 3.6 \text{ V}, I_{OI}$	_L = +4 mA	GND		0.4	V	
	Output short circuit	V 0V	Serializer GPO outputs		-15		^	
los	current	V _{OUT} = 0 V	Deserializer LVCMOS outputs		-35		mA	
l _{OZ}	TRI-STATE output current	PDB = 0 V, V _{OUT} = 0 V or V _{DD}	LVCMOS outputs	-20		20	μΑ	
LVCM OUTP		NS 1.8V I/O (SERIALIZER	NPUTS, DESERIALIZER	OUTPUTS, GPI, G	PO, CONTR	OL INPUTS	AND	
V _{IH}	High level input voltage	V _{IN} = 1.71 V to 1.89 V		0.65 V _{IN}		V _{IN}	V	
V_{IL}	Low level input voltage	V _{IN} = 1.71 V to 1.89 V		GND		0.35 V _{IN}	V	
I _{IN}	Input current	$V_{IN} = 0 \text{ V or } 1.89 \text{ V, } V_{IN}$	= 1.71 V to 1.89 V	-20	±1	20	μΑ	
V_{OH}	High level output voltage	$V_{DDIO} = 1.71 \text{ V to } 1.89 \text{ V}$	/, I _{OH} = −4 mA	V _{DDIO} – 0.45		V_{DDIO}	V	
V _{OL}	Low level output voltage	V _{DDIO} = 1.71 V to 1.89 V I _{OL} = 4 mA	Deserializer LVCMOS outputs	GND		0.45	V	
	Output short circuit	V 0.V	Serializer GPO outputs		-11			
los	current	V _{OUT} = 0 V	Deserializer LVCMOS outputs		-17		mA	
l _{oz}	TRI-STATE output current	PDB = 0 V, V _{OUT} = 0 V or V _{DD}	LVCMOS outputs	-20		20	μA	

⁽¹⁾ The Electrical Characteristics tables list ensured specifications under the listed Recommended Operating Conditions except as otherwise modified or specified by the Electrical Characteristics Conditions and/or Notes. Typical specifications are estimations only and are not ensured.

⁽²⁾ Current into device pins is defined as positive. Current out of a device pin is defined as negative. Voltages are referenced to ground except VOD, ΔVOD, VTH and VTL which are differential voltages.

⁽³⁾ Typical values represent most likely parametric norms at 1.8 V or 3.3 V, T_A = 25°C, and at the Recommended Operation Conditions at the time of product characterization and are not specified.



	PARAMETER	1	ONDITIONS	MIN	TYP	MAX	UNIT	
LVCMO			R INPUTS, GPI, GPO, COI	NTROL INPUTS A				
V _{IH}	High level input voltage	V _{IN} = 2.52 V to 3.08 V	, , ,	0.7 V _{IN}		V _{IN}		
V _{IL}	Low level input voltage	V _{IN} = 2.52 V to 3.08 V		GND		0.3 V _{IN}	V	
I _{IN}	Input current	$V_{IN} = 0 \text{ V or } 3.08 \text{ V, } V_{IN}$	= 2.52 V to 3.08 V	-20	±1	20	μΑ	
V _{OH}	High level output voltage	V _{DDIO} = 2.52 V to 3.08 V	V , $I_{OH} = -4 \text{ mA}$	V _{DDIO} – 0.4		V_{DDIO}	V	
V _{OL}	Low level output voltage	V _{DDIO} =2.52 V to 3.08 V I _{OL} = 4 mA	Deserializer LVCMOS outputs	GND		0.4	V	
	Output short circuit	V 0.V	Serializer GPO outputs		-11		A	
los	current	V _{OUT} = 0 V	Deserializer LVCMOS outputs		-20		mA	
l _{OZ}	TRI-STATE output current	$PDB = 0 V,$ $V_{OUT} = 0 V \text{ or } V_{DD}$	LVCMOS outputs	-20		20	μΑ	
CML DRIVER DC SPECIFICATIONS (DOUT+, DOUT-)								
V _{OD}	Output differential voltage	$R_L = 100 \Omega \text{ (see Figure 9)}$		268	340	412	mV	
ΔV_{OD}	Output differential voltage unbalance	R _L = 100 Ω			1	50	mV	
V _{OS}	Output differential offset voltage	$R_L = 100 \Omega$ (see Figure	$R_L = 100 \Omega$ (see Figure 9)		DD - V _{OD/2}		V	
ΔV _{OS}	Offset voltage unbalance	R _L = 100 Ω			1	50	mV	
Ios	Output short circuit current	DOUT± = 0 V			-26		mA	
R _T	Differential internal termination resistance	Differential across DOU	T+ and DOUT-	80	100	120	Ω	
CML RE	ECEIVER DC SPECIFIC	CATIONS (RIN0+, RIN0-	, RIN1+, RIN1-)					
I _{IN}	Input current	$V_{IN} = V_{DD}$ or 0 V, $V_{DD} =$	1.89 V	-20	1	20	μΑ	
R _T	Differential internal termination resistance	Differential across RIN+	and RIN-	80	100	120	Ω	
CML RE	ECEIVER AC SPECIFIC	CATIONS (RIN0+, RIN0-	, RIN1+, RIN1-)	1				
V _{swing}	Minimum allowable swing for 1010 pattern ⁽⁴⁾ Line rate = 1.4 Gbps (see Figure 11)			135			mV	
CML M	ONITOR OUTPUT DRIV	/ER SPECIFICATIONS (CMLOUTP, CMLOUTN)			<u> </u>		
E _w	Differential output eye opening	R _L = 100 Ω			0.45		UI	
E _H	Differential output eye height	Jitter frequency > f / 40	(see Figure 20)		200		mV	

⁽⁴⁾ Specification is ensured by characterization and is not tested in production.



	PARAMETER	TEST CO	ONDITIONS	MIN	TYP	MAX	UNIT
SERIAL	IZER AND DESERIAL	ZER SUPPLY CURRENT	Γ *DIGITAL, PLL, AND AN	ALOG VDD			
			VDDn = 1.89 V VDDIO = 3.6 V f = 100 MHz, 10-bit mode default registers		61	80	mA
I _{DDT}		R_L = 100 Ω WORST CASE pattern (see Figure 6)	VDDn = 1.89 V VDDIO = 3.6 V f = 75 MHz, 12-bit high-frequency mode default registers		61	80	m A
	Serializer (TX) V _{DDn} supply current		VDDn = 1.89 V VDDIO = 3.6 V f = 50 MHz, 12-bit low-frequency mode default registers		61	80	mA
	(includes load current)	(includes load current)	VDDn = 1.89 V VDDIO = 3.6 V f = 100 MHz, 10-bit mode default registers		54		
		R _L = 100 Ω RANDOM PRBS-7 pattern	VDDn = 1.89 V VDDIO = 3.6 V f = 75 MHz, 12-bit high-frequency mode default registers		54		mA
			VDD = 1.89 V VDDIO = 3.6 V f = 50 MHz, 12-bit low-frequency mode default registers		54		
	Serializer (TX) VDDIO supply	$R_L = 100 \Omega$	VDDIO = 1.89 V f = 75 MHz, 12-bit high-freq mode default registers		1.5	3	A
I _{DDIOT}	current (includes load current)	WORST CASE pattern (see Figure 6)	VDDIO = 3.6 V f = 75 MHz, 12-bit high-frequency mode default registers		5	8	mA
	Serializer (TX)	PDB = 0 V; all other	VDDIO = 1.89 V Default registers		300	900	μΑ
I _{DDTZ}	supply current power-down	LVCMOS inputs = 0 V	VDDIO = 3.6 V Default registers		300	900	μΑ
lppic==	Serializer (TX) VDDIO supply	() PDB = 0 V; All other	VDDIO = 1.89 V Default registers		15	100	μΑ
I _{DDIOTZ}	current power-down	LVCMOS Inputs = 0 V	VDDIO = 3.6 V Default registers		15	100	μΑ



	PARAMETER	<u> </u>	ONDITIONS	MIN	TYP	MAX	UNIT
			f = 100 MHz, 10-bit mode		22	42	
		$V_{DDIO} = 1.89 V$ $C_L = 8 pF$ WORST CASE pattern	f = 75 MHz, 12-bit high- freq mode		19	39	mA
		WORDT OAGE pattern	f = 50 MHz, 12-bit low- freq mode		21	32	
			f = 100 MHz, 10-bit mode		15		
		V _{DDIO} = 1.89 V C _L =8pF Random pattern	f = 75 MHz, 12-bit high- freq mode		12		mA
		·	f = 50 MHz, 12-bit low- freq mode		14		
			f = 100 MHz, 10-bit mode		42	55	
		WORST CASE pattern	f = 75 MHz, 12-bit high- freq mode		37	50	mA
	Deserializer (RX) total supply current (includes load current)		f = 50 MHz, 12-bit low- freq mode		25	38	
		$V_{DDIO} = 3.6 \text{ V}$ $C_L = 8 \text{ pF}$ Random pattern pply current	f = 100 MHz, 10-bit mode		35		
			f = 75 MHz, 12-bit high- freq mode		30		mA
			f = 50 MHz, 12-bit low- freq mode		18		
DDIOR		V_{DDIO} = 1.89 V C_L = 4 pF WORST CASE pattern	f = 100 MHz, 10-bit mode		15		
			f = 75 MHz, 12-bit high- freq mode		11		mA
			f = 50 MHz, 12-bit low- freq mode		16		
			f = 100 MHz, 10-bit mode		8		
		$V_{DDIO} = 1.89 V$ $C_L = 4 pF$ Random pattern	f = 75 MHz, 12-bit high- freq mode		4		mA
		random pattom	f = 50 MHz, 12-bit low- freq mode		9		
			f = 100 MHz, 10-bit mode		36		
		$V_{DDIO} = 3.6 \text{ V}$ $C_L = 4 \text{ pF}$ WORST CASE pattern	f = 75 MHz, 12-bit high- freq mode		29		mA
		The state of the patient	f = 50 MHz, 12-bit low- freq mode		20		
		V 0.5.4	f = 100 MHz, 10-bit mode		29		
		$V_{DDIO} = 3.6 V$ $C_L = 4 pF$ Random pattern	f = 75 MHz, 12-bit high- freq mode		22		mA
		Tandon pattoni	f = 50 MHz, 12-bit low- freq mode		13		



over recommended operating supply and temperature ranges unless otherwise specified. (1) (2) (3)

	PARAMETER	TEST CO	ONDITIONS	MIN	TYP	MAX	UNIT
			f = 100 MHz, 10-bit mode		64	110	
I _{DDR}		$V_{DDn} = 1.89 V$ $C_L = 4 pF$ WORST CASE pattern	f = 75 MHz, 12-bit high-frequency mode		67	114	
	Deserializer (RX) VDDn supply current (includes load	serializer (RX) Dn supply current	f = 50 MHz, 12-bit low-frequency mode		63	96	mA
	current)	V _{DDn} = 1.89 V C _L = 4 pF Random pattern	f = 100 MHz, 10-bit mode		57		
			f = 75 MHz, 12-bit high-frequency mode		60		
			f = 50 MHz, 12-bit low-frequency mode		56		
	Deserializer (RX)	PBB = 0 V, all other LVCMOS Inputs=0 V	VDDIO = 1.89 V Default registers		42	400	
I _{DDRZ}	supply current power-down	PBB = 0 V, all other LVCMOS Inputs=0 V	VDDIO = 3.6 V Default registers		42	400	μΑ
	Deserializer (RX)	supply current I VCMOS Inputs = 0 V	V _{DDIO} = 1.89 V		8 40		
I _{DDIORZ}	VDD supply current power-down		V _{DDIO} = 3.6 V		360	800	μΑ

8.6 Timing Requirements: Recommended for Serializer PCLK

		TEST CONDITIONS	PIN/FREQ	MIN	NOM	MAX	UNIT
		10-bit mode		10	Т	50	
t _{TCP}	Transmit clock period	12-bit high-frequency mode		13.33	Т	66.66	ns
		12-bit low-frequency mode		20	Т	100	
t _{TCIH}	Transmit clock input high time			0.4T	0.5T	0.6T	ns
t _{TCIL}	Transmit clock input low time			0.4T	0.5T	0.6T	ns
		20 MHz–100 MHz, 10-bit mode		0.5T	2.5T	0.3T	
t _{CLKT}	PCLK input transition time (Figure 12)	15 MHz to 75 MHz, 12-bit high-frequency mode		0.5T	2.5T	0.3T	ns
		10 MHz to 50 MHz, 12-bit low-frequency mode		0.5T	2.5T	0.3T	
t _{JITO}	PCLK input jitter (PCLK from imager mode)	Refer to jitter freq > f / 40	f = 10 to 100 MHz		0.1T		ns
t _{JIT1}	PCLK input jitter (external oscillator mode)	Refer to jitter freq > f / 40	f = 10 to 100 MHz		1T		ns
t _{JIT2}	External oscillator jitter				0.1		UI

⁽¹⁾ Recommended input timing requirements are input specifications and not tested in production.



8.7 AC Timing Specifications (SCL, SDA) - I²C Compliant

over recommended supply and temperature ranges unless otherwise specified. (See Figure 5)

		TEST CONDITIONS	MIN	NOM MAX	UNIT
RECOM	IMENDED INPUT TIMING R	EQUIREMENTS			
	CCI alask framusansı	Standard mode	>0	100	1-1-1-
f _{SCL}	SCL clock frequency	Fast mode	>0	400	kHz
	CCI Januaria d	Standard mode	4.7		
t_{LOW}	SCL low period	Fast mode	1.3		μs
	SCL high period	Standard mode	4.0		
t _{HIGH}	SCL nign period	Fast mode	0.6		μs
	Hold time for a start or a repeated start condition	Standard mode	4		
t _{HD:STA}		Fast mode	0.6		μs
t _{SU:STA}	Setup time for a start or a repeated start condition	Standard mode	4.7		
		Fast mode	0.6		μs
	Data hold time	Standard mode	0	3.45	
t _{HD:DAT}		Fast mode	0	900	μs
	Data actus timo	Standard mode	250		no
t _{SU:DAT}	Data setup time	Fast mode	100		ns
	Setup time for STOP	Standard mode	4		
t _{SU:STO}	condition	Fast mode	0.6		μs
	Bus free time between	Standard mode	4.7		
t _{BUF}	stop and start	Fast mode	1.3		μs
	SCL and SDA rise time	Standard mode		1000	
t _r		Fast mode		300	ns
	SCI and SDA fall time	Standard mode		300	200
t _f	SCL and SDA fall time	Fast mode		300	ns

8.8 Bidirectional Control Bus DC Timing Specifications (SCL, SDA) - I²C Compliant

over recommended supply and temperature ranges unless otherwise specified (1)

		TEST CONDITIONS	MIN	NOM	MAX	UNIT
RECO	MMENDED INPUT TIMING	REQUIREMENTS	1			
V_{IH}	Input high level	SDA and SCL	$0.7 \times V_{DDIO}$		V_{DDIO}	V
V _{IL}	Input low level	SDA and SCL	GND		0.3 × V _{DDIO}	V
V_{HY}	Input hysteresis			>50		mV
V _{OL}	Output low level	SDA, I _{OL} = 0.5 mA	0		0.4	V
I _{IN}	Input current	SDA or SCL, V _{IN} = V _{DDOP} OR GND	-10		10	μΑ
t _R	SDA rise time-READ	SDA, RPU = $10 \text{ k}\Omega$, Cb $\leq 400 \text{ pF}$ (see		430		ns
t _F	SDA fall time-READ	Figure 5)		20		ns
t _{SU;DAT}		See Figure 5		560		ns
t _{HD;DAT}		See Figure 5		615		ns
t _{SP}				50		ns
C _{IN}		SDA or SCL		<5		pF

⁽¹⁾ Specification is ensured by design.



8.9 Switching Characteristics: Serializer

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{LHT}	CML low-to-high transition time	$R_L = 100 \Omega$ (see Figure 7)		150	330	ps
t _{HLT}	CML high-to-low transition time	$R_L = 100 \Omega$ (see Figure 7)		150	330	ps
t _{DIS}	Data input setup to PCLK		2			ns
t _{DIH}	Data input hold from PCLK	Serializer data inputs (see Figure 13)	2			ns
t _{PLD}	Serializer PLL lock time	$R_L = 100 \ \Omega^{(1)} \ ^{(2)}$, (see Figure 14)		1	2	ms
+	Serializer delay ⁽²⁾	R_T = 100 Ω , 10-bit mode Register 0x03h b[0] (TRFB = 1) (see Figure 15)	32.5T	38T	44T	ns
t _{SD}	Serializer delay\-	R_T = 100 Ω , 12-bit mode Register 0x03h b[0] (TRFB = 1) (see Figure 15)	11.75T	13T	15T	115
t _{JIND}	Serializer output deterministic jitter	Serializer output intrinsic deterministic jitter. Measured (cycle-cycle) with PRBS-7 test pattern ⁽³⁾ (⁴⁾	0.13		UI	
t _{JINR}	Serializer output random jitter	Serializer output intrinsic random jitter (cyclecycle). Alternating-1,0 pattern. (3) (4)	0.04		UI	
t _{JINT}	Peak-to-peak serializer output jitter	Serializer output peak-to-peak jitter includes deterministic jitter, random jitter, and jitter transfer from serializer input. Measured (cycle-cycle) with PRBS-7 test pattern. (3) (4)		0.396		UI
		PCLK = 100 MHz 10-bit mode. Default registers		2.2		
λ_{STXBW}	Serializer jitter transfer function –3-dB bandwidth ⁽⁵⁾	PCLK = 75 MHz 12-bit high-frequency mode. Default registers		2.2		MHz
	banawaan	PCLK = 50 MHz 12-bit low-frequency mode. Default registers		2.2		
		PCLK = 100 MHz 10-bit mode. Default Registers		1.06		
δ_{STX}	Serializer jitter transfer function (peaking) ⁽⁵⁾	PCLK = 75 MHz 12-bit high-frequency mode. Default registers		1.09		dB
	(1-23)	PCLK = 50 MHz 12-bit low-frequency mode. Default registers		1.16		
		PCLK = 100 MHz 10-bit mode. Default registers		400		
δ_{STXf}	Serializer jitter transfer function (peaking frequency) ⁽⁵⁾	PCLK = 75 MHz 12-bit high-frequency mode. Default registers		500		kHz
		PCLK = 50 MHz 12-bit low-frequency mode. Default registers		600		

 ⁽¹⁾ t_{PLD} and t_{DDLT} is the time required by the serializer and deserializer to obtain lock when exiting power-down state with an active PCLK
 (2) Specification is ensured by design.

Typical values represent most likely parametric norms at 1.8 V or 3.3 V, $T_A = 25$ °C, and at the recommended operation conditions at the time of product characterization and are not specified.

UI - Unit Interval is equivalent to one ideal serialized data bit width. The UI scales with PCLK frequency.

⁽⁵⁾ Specification is ensured by characterization and is not tested in production.



8.10 Switching Characteristics: Deserializer

	PARAMETER	TEST CONDITIONS	PIN/FREQ	MIN	TYP	MAX	UNIT
		10-bit mode		10		50	
t _{RCP}	Receiver output clock period	12-bit high-frequency mode	PCLK (see Figure 19)	13.33		66.66	ns
		12-bit low-frequency mode	Tigure 10,	10		100	
		10-bit mode		45%	50%	55%	
t _{PDC}	PCLK duty cycle	12-bit high-frequency mode	PCLK	40%	50%	60%	
		12-bit low-frequency mode		40%	50%	60%	
t _{CLH}	LVCMOS low-to-high transition time	V _{DDIO} : 1.71 V to 1.89 V or 3.0 V to 3.6 V,		1.3	2	2.8	ns
t _{CHL}	LVCMOS high-to-low transition time	C _L = 8 pF (lumped load) Default registers (see Figure 17) ⁽¹⁾	PCLK	1.3	2	2.8	ns
t _{CLH}	LVCMOS low-to-high transition time	V _{DDIO} : 1.71 V to 1.89 V or 3.0 V to 3.6 V,	ROUT[11:0], HS,	1	2.5	4	ns
t _{CHL}	LVCMOS high-to-low transition time	C _L = 8 pF (lumped load) Default registers (see Figure 17) ⁽¹⁾	VS VS	1	2.5	4	ns
t _{ROS}	ROUT setup data to PCLK	V _{DDIO} : 1.71 V to 1.89 V or 3.0 V to 3.6 V,	ROUT[11:0], HS,	0.38T	0.5T		ns
t _{ROH}	ROUT hold data to PCLK	C _L = 8 pF (lumped load) Default registers (see Figure 19)	VS	0.38T	0.5T		ns
	Deserializer delay	Default registers Register 0x03h b[0] (RRFB = 1) (see Figure 18) ⁽¹⁾	10-bit mode	154T		158T	
t _{DD}			12-bit low- frequency mode	109T		112T	ns
			12-bit high- frequency mode	73T		75T	
			10-bit mode		15	22	
t _{DDLT}	Deserializer data lock time	With Adaptive Equalization (see	12-bit low- frequency mode		15	22	ms
		Figure 16)	12-bit high- frequency mode		15	22	
			10-bit mode PCLK = 100 MHz		20	30	
t _{RCJ}	Receiver clock jitter	PCLK SSCG[3:0] = OFF ⁽¹⁾	12-bit low- frequency mode PCLK = 50 MHz		22	35	ps
			12-bit high- frequency mode PCLK = 75 MHz		45	90	
			10-bit mode PCLK = 100 MHz		170	815	
t _{DPJ}	Deserializer period jitter	rializer period jitter PCLK SSCG[3:0] = OFF ⁽¹⁾ (2)	12-bit low- frequency mode PCLK= 50 MHz		180	330	ps
			12-bit high- frequency mode PCLK= 75 MHz		300	515	

 ⁽¹⁾ Specification is ensured by characterization and is not tested in production.
 (2) t_{DPJ} is the maximum amount the period is allowed to deviate measured over 30,000 samples.



Switching Characteristics: Deserializer (continued)

	PARAMETER	TEST CONDITIONS	PIN/FREQ	MIN	TYP	MAX	UNIT
		PCLK SSCG[3:0] = OFF ⁽¹⁾ (3)	10-bit mode PCLK = 100 MHz		440	1760	
	Deserializer cycle-to- cycle clock jitter		12-bit low- frequency mode PCLK = 50 MHz		460	730	ps
			12-bit high- frequency mode PCLK = 75 MHz		565	985	
fdev	Spread spectrum clocking deviation frequency	LVCMOS output bus	10 MHz-100 MHz		±0.5 to ±1.5%		
fmod	Spread spectrum clocking modulation frequency	SSC[3:0] = ON (see Figure 24) ⁽¹⁾	10 MHz-100 MHz		5 to 50		kHz

⁽³⁾ t_{DCCJ} is the maximum amount of jitter between adjacent clock cycles measured over 30,000 samples.



8.11 Typical Characteristics

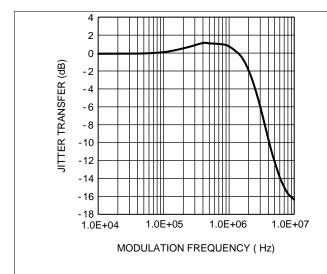


Figure 1. Typical Serializer Jitter Transfer Function at 100 MHz

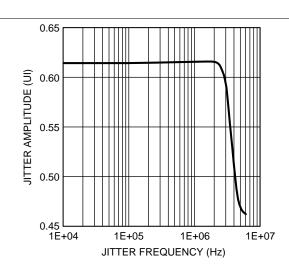


Figure 2. Typical Deserializer Input Jitter Tolerance Curve at 1.4-Gbps Line Rate

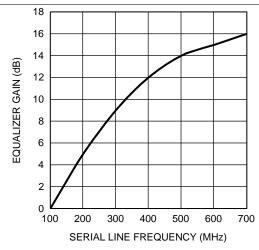


Figure 3. Maximum Equalizer Gain vs. Line Frequency

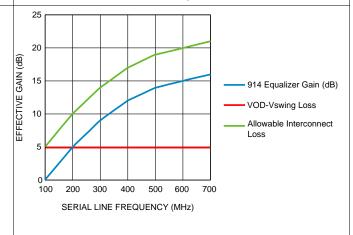


Figure 4. Adaptive Equalizer – Interconnect Loss Compensation

9 Parameter Measurement Information

9.1 AC Timing Diagrams and Test Circuits

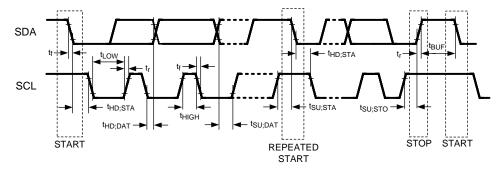


Figure 5. Bidirectional Control Bus Timing

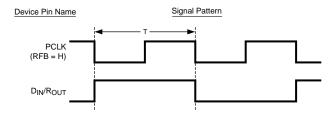


Figure 6. Worst Case Test Pattern

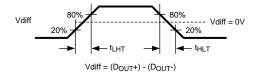


Figure 7. Serializer CML Output Load and Transition Times

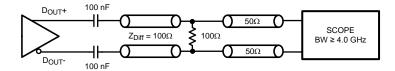


Figure 8. Serializer CML Output Load and Transition Times

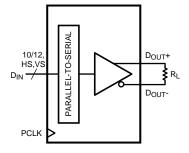


Figure 9. Serializer VOD Diagram



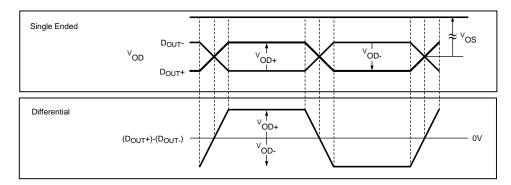


Figure 10. Serializer VOD Diagram

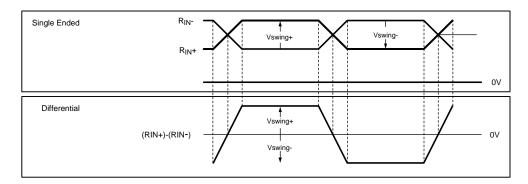
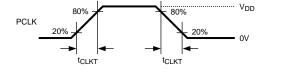


Figure 11. Differential Vswing Diagram



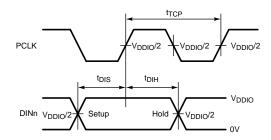


Figure 12. Serializer Input Clock Transition Times

Figure 13. Serializer Set-Up and Hold Times

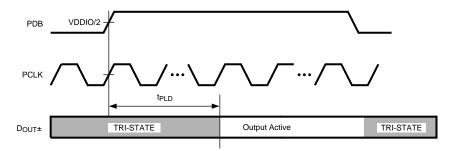


Figure 14. Serializer PLL Lock Time

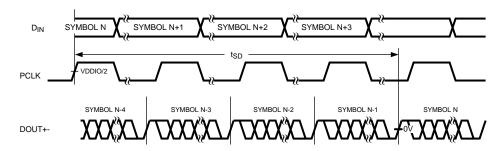


Figure 15. Serializer Delay

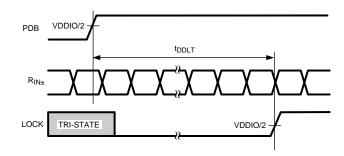


Figure 16. Deserializer Data Lock Time

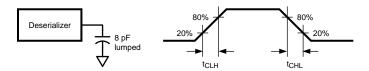


Figure 17. Deserializer LVCMOS Output Load and Transition Times

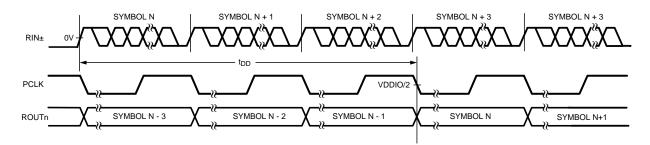


Figure 18. Deserializer Delay

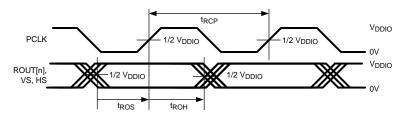


Figure 19. Deserializer Output Set-Up and Hold Times

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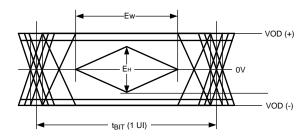


Figure 20. CML Output Driver

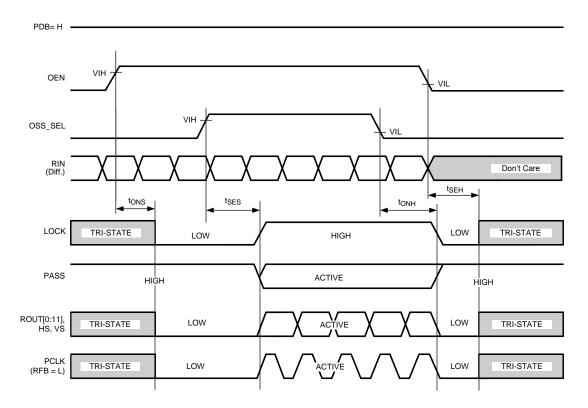


Figure 21. Output State (Set-Up and Hold) Times

TEXAS INSTRUMENTS

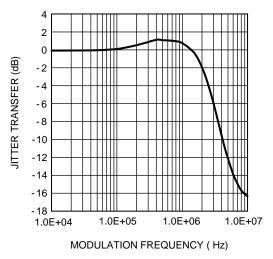


Figure 22. Typical Serializer Jitter Transfer Function at 100 MHz

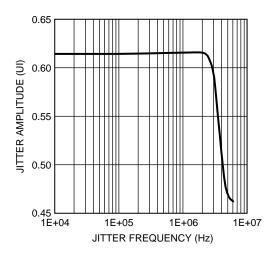


Figure 23. Typical Deserializer Input Jitter Tolerance Curve at 1.4-Gbps Line Rate

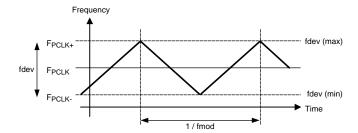


Figure 24. Spread Spectrum Clock Output Profile



10 Detailed Description

10.1 Overview

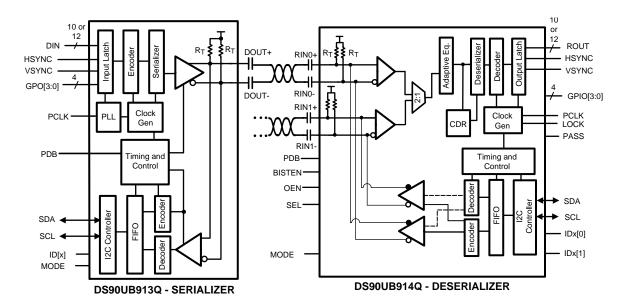
The DS90UB91xQ-Q1 FPD-Link III chipsets are intended to link megapixel camera imagers and video processors in ECUs. The serializer and deserializer chipset can operate from 10-MHz to 100-MHz pixel clock frequency. The DS90UB913Q-Q1 device transforms a 10- and 12-bit wide parallel LVCMOS data bus along with a bidirectional control channel control bus into a single high-speed differential pair. The high-speed serial bit stream contains an embedded clock and DC-balanced information which enhances signal quality to support AC coupling. The DS90UB914Q-Q1 device receives the single serial data stream and converts it back into a 10- and 12-bit wide parallel data bus together with the control channel data bus. The DS90UB91xQ-Q1 chipsets can accept up to:

- 12 bits of DATA+2 bits SYNC for an input PCLK range of 10 MHz-50 MHz in the 12-bit low-frequency mode
- 12 bits DATA + 2 SYNC bits for an input PCLK range of 15 MHz to 75 MHz in the 12-bit high-frequency mode
- 10 bits DATA + 2 SYNC bits for an input PCLK range of 20 MHz to 100 MHz in the 10-bit mode.

The DS90UB914Q-Q1 chipset has a 2:1 multiplexer that allows customers to select between two serializer inputs. The control channel function of the DS90UB91xQ-Q1 chipset provides bidirectional communication between the image sensor and ECUs. The integrated bidirectional control channel transfers data bidirectionally over the same differential pair used for video data interface. This interface offers advantages over other chipsets by eliminating the need for additional wires for programming and control. The bidirectional control channel bus is controlled through an I²C port. The bidirectional control channel offers asymmetrical communication and is not dependent on video blanking intervals.

The DS90UB91xQ-Q1 chipset offer customers the choice to work with different clocking schemes. The DS90UB91xQ-Q1 chipsets can use an external oscillator as the reference clock source for the PLL or PCLK from the imager as primary reference clock to the PLL.

10.2 Functional Block Diagram



10.3 Feature Description

10.3.1 Serial Frame Format

The high-speed forward channel is composed of 28 bits of data containing video data, sync signals, I²C and parity bits. This data payload is optimized for signal transmission over an AC-coupled link. Data is randomized, balanced and scrambled. The 28-bit frame structure changes in the 12-bit low-frequency mode, 12-bit high frequency mode and the 10-bit mode internally and is seamless to the customer. The bidirectional control channel data is transferred over the single serial link along with the high-speed forward data. This architecture provides a full duplex low-speed forward and backward path across the serial link together with a high-speed forward channel without the dependence on the video blanking phase.

10.3.2 Line Rate Calculations for the DS90UB91xQ

The DS90UB913Q-Q1 device divides the clock internally by divide-by-1 in the 12-bit low-frequency mode, by divide-by-2 in the 10-bit mode and by divide-by-1.5 in the 12-bit high-frequency mode. Conversely, the DS90UB914Q-Q1 multiplies the recovered serial clock to generate the proper pixel clock output frequency. Thus the maximum line rate in the three different modes remains 1.4 Gbps. The following are the formulae used to calculate the maximum line rate in the different modes.

- For 12-bit low-frequency mode, Line rate = $f_{PCLK} \times 28$; that is, $f_{PCLK} = 50$ MHz, line rate = $50 \times 28 = 1.4$ Gbps
- For 10-bit mode, Line rate = f_{PCLK} / 2 × 28; that is, f_{PCLK} = 100 MHz, line rate = (100 / 2) × 28 = 1.4 Gbps
- For the 12-bit high-frequency mode, Line rate = $f_{PCLK} \times (2/3) \times 28$; that is, $f_{PCLK} = 75$ MHz, line rate = (75) $\times (2/3) \times 28 = 1.4$ Gbps

10.3.3 Deserializer Multiplexer Input

The DS90UB914Q-Q1 offers a 2:1 multiplexer that can be used to select which camera is used as the input. Figure 25 shows the operation of the 2:1 multiplexer in the deserializer. The selection of the camera can be pin controlled as well as register controlled. Both the deserializer inputs cannot be enabled at the same time. If the Serializer A is selected as the active serializer, the back-channel for Deserializer A turns ON and vice versa. To switch between the two cameras, first the Serializer B has to be selected using the SEL pin/register on the deserializer. After that the back channel driver for Deserializer B has to be enabled using the register in the deserializer.

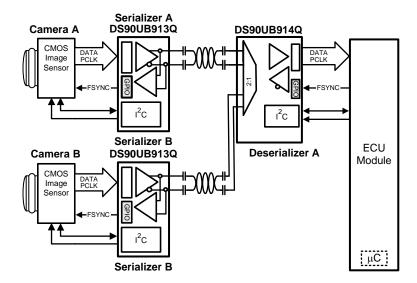


Figure 25. Using the Multiplexer on the Deserializer to Enable a Two-Camera System



Feature Description (continued)

10.3.4 Error Detection

The chipset provides error detection operations for validating data integrity in long distance transmission and reception. The data error detection function offers users flexibility and usability of performing bit-by-bit data transmission error checking. The error detection operating modes support data validation of the following signals:

- · Bidirectional control channel data across the serial link
- Parallel video/sync data across the serial link

The chipset provides one parity bit on the forward channel and 4 CRC bits on the back channel for error detection purposes. The DS90UB91xQ-Q1 chipset checks the forward and back channel serial links for errors and stores the number of detected errors in two 8-bit registers in the serializer and the deserializer respectively.

To check parity errors on the forward-channel, monitor registers 0x1A and 0x1B on the deserializer. If there is a loss of LOCK, then the counters on registers 0x1A and 0x1B are reset.

NOTE

Whenever there is a parity error on the forward channel, the PASS pin will go low.

To check CRC errors on the back-channel, monitor registers 0x0A and 0x0B on the serializer.

10.3.5 Description of Bidirectional Control Bus and I²C Modes

The I²C-compatible interface allows programming of the DS90UB913Q-Q1, DS90UB914Q-Q1, or an external remote device (such as image sensor) through the bidirectional control channel. Register programming transactions to/from the DS90UB913xQ-Q1 chipset are employed through the clock (SCL) and data (SDA) lines. These two signals have open-drain I/Os and both lines must be pulled up to VDDIO by an external resistor. Pullup resistors or current sources are required on the SCL and SDA busses to pull them high when they are not being driven low. A logic LOW is transmitted by driving the output low. Logic HIGH is transmitted by releasing the output and allowing it to be pulled up externally. The appropriate pullup resistor values will depend upon the total bus capacitance and operating speed. The DS90UB91xQ-Q1 I²C bus data rate supports up to 400 kbps according to I²C fast mode specifications.

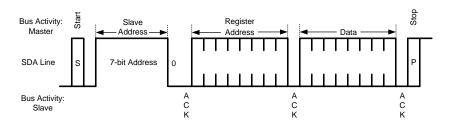


Figure 26. Write Byte

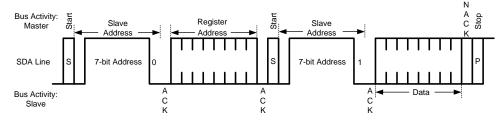


Figure 27. Read Byte

Feature Description (continued)

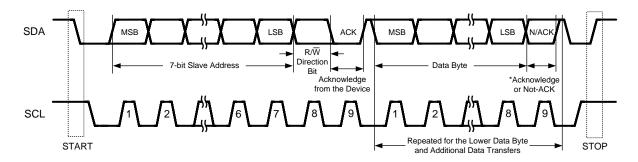


Figure 28. Basic Operation

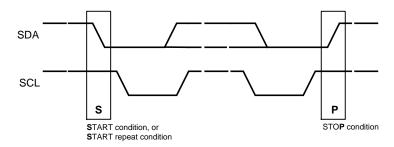


Figure 29. Start and Stop Conditions

10.3.6 Slave Clock Stretching

The I²C-compatible interface allows programming of the DS90UB913Q-Q1, DS90UB914Q-Q1, or an external remote device (such as image sensor) through the bidirectional control.

NOTE

To communicate and synchronize with remote devices on the I^2C bus through the bidirectional control channel/MCU, the chipset utilizes bus clock stretching (holding the SCL line low) during data transmission where the I^2C slave pulls the SCL line low on the 9th clock of every I^2C transfer (before the ACK signal).

The slave device will not control the clock and only stretches it until the remote peripheral has responded. The I^2C master must support clock stretching to operate with the DS90UB91xQ-Q1 chipset.

10.3.7 I²C Pass-Through

I²C pass-through provides an alternative means to independently address slave devices. The mode enables or disables I²C bidirectional control channel communication to the remote I²C bus. This option is used to determine whether or not an I²C instruction is to be transferred over to the remote I²C device. When enabled, the I²C bus traffic will continue to pass through, I²C commands will be excluded to the remote I²C device. The pass-through function also provides access and communication to only specific devices on the remote bus.

See Figure 30 for an example of this function.

If master controller transmits I²C transaction for address 0xA0, the SER A with I²C pass-through enabled will transfer I²C commands to remote Camera A. The SER B with I²C pass-through disabled, any I²C commands will be bypassed on the I²C bus to Camera B.



Feature Description (continued)

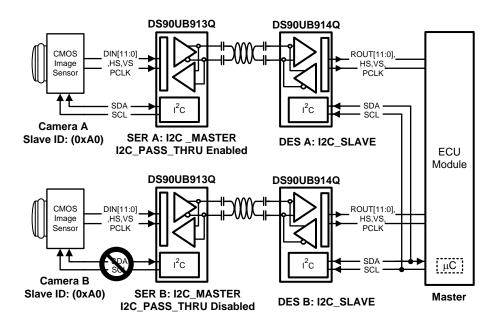


Figure 30. I²C Pass-Through

10.3.8 ID[x] Address Decoder on the Serializer

The ID[x] pin on the serializer is used to decode and set the physical slave address of the serializer (I 2 C only) to allow up to five devices on the bus connected to the serializer using only a single pin. The pin sets one of the 5 possible addresses for each serializer device. The pin must be pulled to VDD (1.8 V, not VDDIO) with a 10-k Ω resistor and a pulldown resistor (RID) of the recommended value to set the physical device address. The recommended maximum resistor tolerance is 1%.

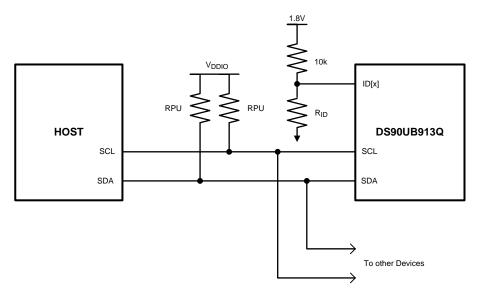


Figure 31. ID[x] Address Decoder on the Serializer



Table 1. ID[x] Resistor Value for DS90UB913Q-Q1 S

ID[x] Resistor Value — DS90UB913Q-Q1 Serializer			
Resistor RID0 Ω (1% Tolerance)	Address 7'b	Address 8'b 0 appended (WRITE)	
0 k	0x58	0xB0	
2 k	0x59	0xB2	
4.7 k	0x5A	0xB4	
8.2 k	0x5B	0xB6	
14 k	0x5C	0xB8	
100 k	0x5D	0xBA	

10.3.9 ID[x] Address Decoder on the Deserializer

The IDx[0] and IDx[1] pins on the deserializer are used to decode and set the physical slave address of the deserializer (I²C only) to allow up to 16 devices on the bus using only two pins. The pins set one of 16 possible addresses for each deserializer device. As there will be more deserializer devices connected on the same board than serializers, more I²C device addresses have been defined for the DS90UB914Q-Q1 deserializer than the DSDS90UB913Q-Q1 serializer. The pins must be pulled to VDD (1.8 V, not VDDIO) with a 10-k Ω resistor and two pulldown resistors (RID0 and RID1) of the recommended value to set the physical device address. The recommended maximum resistor tolerance is 1%.

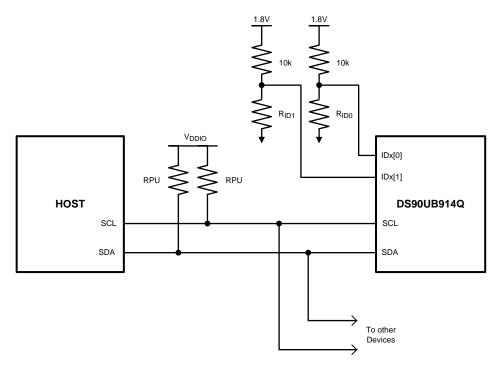


Figure 32. ID[x[Address Decoder on the Deserializer

Table 2. Resistor Values for IDx[0] and IDx[1] on DS90UB914Q-Q1 Deserializer

ID[X] RESISTOR VALUE — DS90UB913Q SERIALIZER			
RESISTOR RID1 Ω (1%TOLERANCE)	RESISTOR RIDO Ω (1%TOLERANCE)	ADDRESS 7'b	ADDRESS 8'b 0 APPENDED (WRITE)
0 k	0 k	0x60	0xC0
0 k	3 k	0x61	0xC2
0 k	11 k	0x62	0xC4
0 k	100 k	0x63	0xC6
3 k	0 k	0x64	0xC8



Table 2. Resistor Values for IDx[0] and IDx[1] on DS90UB914Q-Q1 Deserializer (continued)

ID[X] RESISTOR VALUE — DS90UB913Q SERIALIZER			
3 k	3 k	0x65	0xCA
3 k	11 k	0x66	0XCC
3 k	100 k	0x67	0XCE
11 k	0 k	0x68	0XD0
11 k	3 k	0x69	0XD2
11 k	11 k	0x6A	0XD4
11 k	100 k	0x6B	0XD6
100 k	0 k	0x6C	0XD8
100 k	3 k	0x6D	0XDA
100 k	11 k	0x6E	0XDC
100 k	100 k	0x6F	0XDE

10.3.10 Programmable Controller

An integrated I²C slave controller is embedded in the DS90UB913Q-Q1 serializer as well as the DS90UB914Q-Q1 deserializer. It must be used to configure the extra features embedded within the programmable registers or it can be used to control the set of programmable GPIOs.

10.3.11 Synchronizing Multiple Cameras

For applications requiring multiple cameras for frame-synchronization, TI recommends to utilize the General-Purpose Input/Output (GPIO) pins to transmit control signals to synchronize multiple cameras together. To synchronize the cameras properly, the system controller needs to provide a field sync output (such as a vertical or frame sync signal) and the cameras must be set to accept an auxiliary sync input. The vertical synchronize signal corresponds to the start and end of a frame and the start and end of a field.

NOTE

this form of synchronization timing relationship has a non-deterministic latency. After the control data is reconstructed from the bidirectional control channel, there will be a time variation of the GPIO signals arriving at the different target devices (between the parallel links). The maximum latency delta (t1) of the GPIO data transmitted across multiple links is $25 \, \mu s$.

NOTE

The user must verify that the timing variations between the different links are within their system and timing specifications.



See Figure 33 for an example of synchronizing multiple cameras.

The maximum time (t1) between the rising edge of GPIO (that is, sync signal) arriving at Camera A and Camera B is 25 µs.

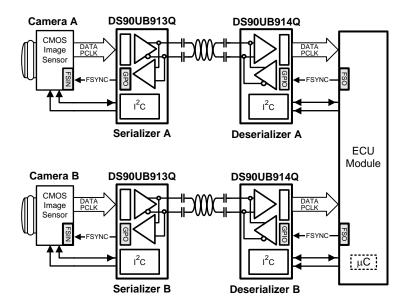


Figure 33. Synchronizing Multiple Cameras

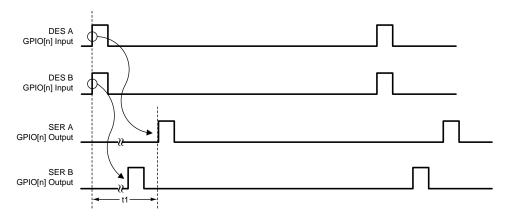


Figure 34. GPIO Delta Latency

10.3.12 General-Purpose I/O (GPIO) Descriptions

There are 4 GPOs on the serializer and 4 GPIOs on the deserializer when the DS90UB91xQ-Q1 chipsets are run off the pixel clock from the imager as the reference clock source. The GPOs on the serializer can be configured as outputs for the input signals that are fed into the deserializer GPIOs. In addition, the GPOs on the serializer can behave as outputs of the local register on the serializer. The GPIOs on the deserializer can be configured to be the input signals feeding the output of the GPOs on the serializer. In addition the GPIOs on the deserializer can be configured to behave as outputs of the local register on the deserializer. If the DS90UB91xQ-Q1 chipsets are run off the external oscillator source as the reference clock, then GPO3 on the serializer is automatically configured to be the input for the external clock and GPIO2 on the deserializer is configured to be the output of the divide-by-2 clock which is fed into the imager as its reference clock. In this case, the GPIO2 and GPIO3 on the deserializer can only behave as outputs of the local register on the deserializer. The GPIO maximum switching rate is up to 66 kHz when configured for communication between deserializer GPIO to serializer GPO.



10.3.13 LVCMOS VDDIO Option

1.8-V, 2.8-V, and 3.3-V serializer inputs and 1.8-V and 3.3-V deserializer outputs are user configurable to provide compatibility with 1.8-V, 2.8-V and 3.3-V system interfaces.

10.3.14 Deserializer – Adaptive Input Equalization (AEQ)

The receiver inputs provide an adaptive input equalization filter in order to compensate for loss from the media. The level of equalization can also be manually selected through register controls. The fully-adaptive equalizer output can be seen using the CMLOUTP/CMLOUTN pins in the describilizer.

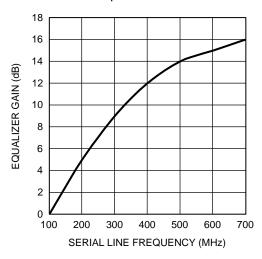


Figure 35. Maximum Equalizer Gain vs. Line Frequency

10.3.15 EMI Reduction

10.3.15.1 Deserializer Staggered Output

The receiver staggers output switching to provide a random distribution of transitions within a defined window. Outputs transitions are distributed randomly. This minimizes the number of outputs switching simultaneously and helps to reduce supply noise. In addition it spreads the noise spectrum out reducing overall EMI.

10.3.15.2 Spread Spectrum Clock Generation (SSCG) on the Deserializer

The DS90UB914Q-Q1 parallel data and clock outputs have programmable SSCG ranges from 10 MHz to 100 MHz. The modulation rate and modulation frequency variation of output spread is controlled through the SSC control registers on the DS90UB914Q-Q1 device. SSC profiles can be generated using bits [3:0] in register 0x02 in the deserializer.

10.4 Device Functional Modes

10.4.1 DS90UB91xQ-Q1 Operation With External Oscillator as Reference Clock

In some applications, the pixel clock that comes from the imager can have jitter which exceeds the tolerance of the DS90UB91xQ-Q1 chipsets. In this case, the DS90UB913Q-Q1 device should be operated by using an external clock source as the reference clock for the DS90UB91xQ-Q1 chipsets. This is the recommended operating mode. The external oscillator clock output goes through a divide-by-2 circuit in the DS90UB913Q-Q1 serializer and this divided clock output is used as the reference clock for the imager. The output data and pixel clock from the imager are then fed into the DS90UB913Q-Q1 device. Figure 36 shows the operation of the DS90UB1xQ-Q1 chipsets while using an external automotive grade oscillator.



Device Functional Modes (continued)

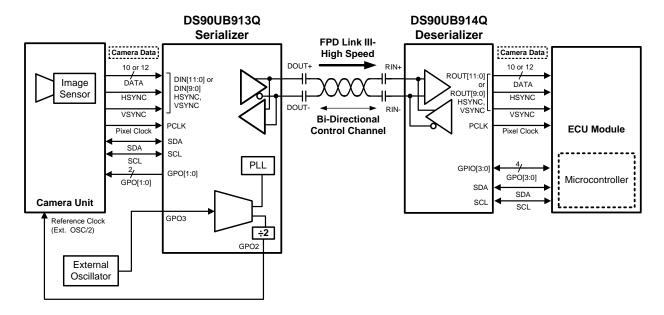


Figure 36. DS90UB91xQ-Q1 Operation in the External Oscillator Mode

When the DS90UB913Q-Q1 device is operated using an external oscillator, the GPO3 pin on the DS90UB913Q-Q1 is the input pin for the external oscillator. In applications where the DS90UB913Q-Q1 device is operated from an external oscillator, the divide-by-2 circuit in the DS90UB913Q-Q1 device feeds back the divided clock output to the imager device through GPO2 pin. The pixel clock to external oscillator ratios needs to be fixed for the 12-bit high-frequency mode and the 10-bit mode.

NOTE

In the 10-bit mode, the pixel clock frequency divided by the external oscillator frequency must be 2. In the 12-bit high-frequency mode, the pixel clock frequency divided by the external oscillator frequency must be 1.5.

For example, if the external oscillator frequency is 48 MHz in the 10-bit mode, the pixel clock frequency of the imager needs to be twice of the external oscillator frequency, that is, 96 MHz. If the external oscillator frequency is 48 MHz in the 12-bit high-frequency mode, the pixel clock frequency of the imager needs to be 1.5 times of the external oscillator frequency, that is, 72 MHz. In this mode, GPO2 and GPO3 on the serializer cannot act as the output of the input signal coming from GPIO2 or GPIO3 on the deserializer.

10.4.2 DS90UB91xQ-Q1 Operation With Pixel Clock from Imager as Reference Clock

The DS90UB91xQ-Q1 chipsets can be operated by using the pixel clock from the imager as the reference clock. Figure 37 shows the operation of the DS90UB91xQ-Q1 chipsets using the pixel clock from the imager. If the DS90UB913Q-Q1 device is operated using the pixel clock from the imager as the reference clock, then the imager uses an external oscillator as its reference clock. There are 4 GPIOs on the serializer and 4 GPIOs on the deserializer in this mode.



Device Functional Modes (continued)

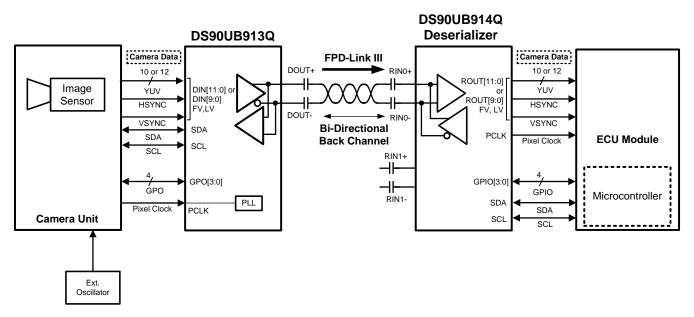


Figure 37. DS90UB91xQ-Q1 Operation in PCLK mode

10.4.3 MODE Pin on Serializer

The mode pin on the serializer can be configured to select if the DS90UB913Q-Q1 device is to be operated from the external oscillator or the PCLK from the imager. The pin must be pulled to V_{DD} (1.8 V, not V_{DDIO}) with a 10-k Ω resistor and a pulldown resistor (R_{MODE}) of the recommended value to set the modes shown in Figure 38. The recommended maximum resistor tolerance is 1%.

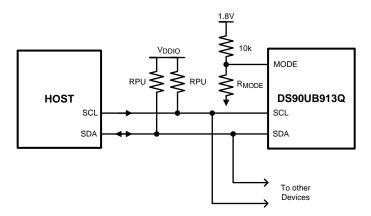


Figure 38. MODE Pin Configuration on DS90UB913Q-Q1

Table 3. DS90UB913Q-Q1 Serializer MODE Resistor Value

MODE SELECT	R _{MODE} RESISTOR VALUE
PCLK from imager mode	100 kΩ
External Oscillator mode	4.7 kΩ



10.4.4 MODE Pin on Deserializer

The mode pin on the deserializer can be used to configure the device to work in the 12-bit low-frequency mode, 12-bit high frequency mode or the 10-bit mode of operation. Internally, the DS90UB91xQ-Q1 chipset operates in a divide-by-1 mode in the 12-bit low-frequency mode, divide-by-2 mode in the 10-bit mode and a divide-by-1.5 mode in the 12-bit high-frequency mode. The pin must be pulled to V_{DD} (1.8 V, not V_{DDIO}) with a 10-k Ω resistor and a pulldown resistor (R_{MODE}) of the recommended value to set the different modes in the deserializer as mentioned in Table 4. The deserializer automatically configures the serializer to correct mode through the back-channel. The recommended maximum resistor tolerance is 1%

.

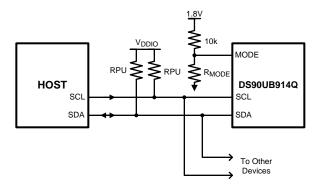


Figure 39. Mode Pin Configuration on DS90UB914Q-Q1 Deserializer

Table 4. DS90UB914Q-Q1 Deserializer MODE Resistor Value

DS90UB914Q-Q1 DESERIALIZER MODE RESISTOR VALUE		
MODE SELECT	R _{MODE} RESISTOR VALUE	
12-bit low-frequency mode 10 to 50 MHz PCLK 10 to 12 bit DATA + 2 SYNC	0 Ω	
12-bit low-frequency mode 15 to 75 MHz PCLK 10 to 12 bit DATA + 2 SYNC	3 kΩ	
10-bit mode 20 to 100 MHz PCLK 10 to 10 bit DATA + 2 SYNC	11 kΩ	



10.4.5 Clock-Data Recovery Status Flag (LOCK), Output Enable (OEN) and Output State Select (OSS_SEL)

When PDB is driven HIGH, the CDR PLL of the deserializer begins locking to the serial input and LOCK is TRI-STATE or LOW (depending on the value of the OEN setting). After the DS90UB914Q-Q1 completes its lock sequence to the input serial data, the LOCK output is driven HIGH, indicating valid data and clock recovered from the serial input is available on the parallel bus and PCLK outputs. The states of the outputs are based on the OEN and OSS_SEL setting (Table 3). See Figure 20.

INPUTS OUTPUTS DATA, GPIO, I2S **SERIAI INPUTS PDB OEN** oss LOCK **PASS CLK** Х 0 Χ Χ Z Z Z Z Χ 1 0 0 L or H L L L Χ 1 0 1 L or H Ζ Ζ Ζ L/Osc (Register L Static 1 1 0 L L Bit Enable) Н **Previous State** Static 1 1 L 1 1 1 1 0 Н ı ı 1 Active Active 1 1 1 Н Valid Valid Valid

Table 5. Output States

10.4.6 Multiple Device Addressing

Some applications require multiple camera devices with the same fixed address to be accessed on the same I²C bus. The DS90UB91xQ-Q1 provides slave ID matching/aliasing to generate different target slave addresses when connecting more than two identical devices together on the same bus. This allows the slave devices to be independently addressed. Each device connected to the bus is addressable through a unique ID by programming of the SLAVE_ID_MATCH register on deserializer. This will remap the SLAVE_ID_MATCH address to the target SLAVE_ID_INDEX address; up to 8 ID indexes are supported. The ECU Controller must keep track of the list of I²C peripherals in order to properly address the target device.

See Figure 40 for an example of multiple device addressing.

- ECU is the I²C master and has an I²C master interface
- The I²C interfaces in DES A and DES B are both slave interfaces.
- The I²C protocol is bridged from DES A to SER A and from DES B to SER B
- The I²C interfaces in SER A and SER B are both master interfaces

If master controller transmits I^2C slave 0xA0, the DES A address 0xC0 will forward the transaction to remote Camera A. If the controller transmits slave address 0xA4, the DES B 0xC2 will recognize that 0xA4 is mapped to 0xA0 and will be transmitted to the remote Camera B. If controller sends command to address 0xA6, the DES B 0xC2 will forward transaction to slave device 0xA2.

The Slave ID index/match is supported only in the camera mode (SER: MODE pin = L; DES: MODE pin = H). For Multiple device addressing in display mode (SER: MODE pin = H; DES: MODE pin = L), use the I^2C pass-through function.

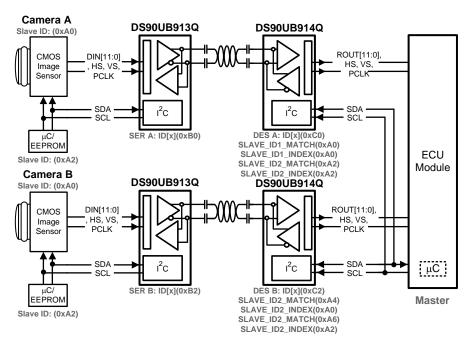


Figure 40. Multiple Device Addressing

10.4.7 Powerdown

The SER has a PDB input pin to ENABLE or Powerdown (SLEEP) the device. The modes can be controlled by the host and is used to disable the Link to save power when the remote device is not operational. In this mode, if the PDB pin is tied High and the SER will enter SLEEP when the PCLK stops. When the PCLK starts again, the SER will then lock to the valid input PCLK and transmit the data to the DES. In SLEEP mode, the high-speed driver outputs are static (High). The DES has a PDB input pin to ENABLE or Powerdown (SLEEP) the device. This pin can be controlled by the system and is used to disable the DES to save power. An auto mode is also available. In this mode, the PDB pin is tied High and the DES will enter SLEEP when the serial stream stops. When the serial stream starts up again, the DES will lock to the input stream and assert the LOCK pin and output valid data. In SLEEP mode, the Data and PCLK outputs are set by the OSS SEL configuration.

10.4.8 Pixel Clock Edge Select (TRFB / RRFB)

The TRFB/RRFB selects which edge of the Pixel Clock is used. For the SER, this register determines the edge that the data is latched on. If TRFB register is 1, data is latched on the Rising edge of the PCLK. If TRFB register is 0, data is latched on the Falling edge of the PCLK. For the DES, this register determines the edge that the data is strobed on. If RRFB register is 1, data is strobed on the Rising edge of the PCLK. If RRFB register is 0, data is strobed on the falling edge of the PCLK.

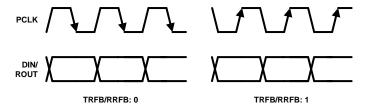


Figure 41. Programmable PCLK Strobe Select



10.4.9 Power-Up Requirements and PDB Pin

When power is applied, the VDDIO supply needs to reach the expected operating voltage (1.8 V to 3.3 V) before the other supplies (VDDn) begin to ramp. It is required to delay and release the PDB Signal after VDD (VDDn and VDDIO) power supplies have settled to the recommended operating voltage. An external RC network can be connected to the PDB pin to ensure PDB arrives after all the VDD has stabilized.

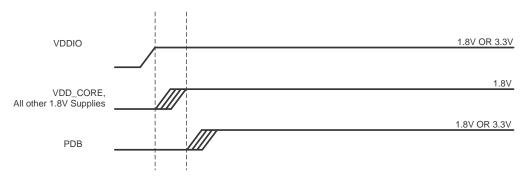


Figure 42. Power-Up Sequencing

10.4.10 Built-In Self Test

An optional AT-Speed, Built-In Self Test (BIST) feature supports the testing of the high-speed serial link and low-speed back channel. This is useful in the prototype stage, equipment production, and in-system test and also for system diagnostics.

10.4.11 BIST Configuration and Status

The chipset can be programmed into BIST mode using either pins or registers. By default BIST configuration is controlled through pins. BIST can be configured through registers using BIST Control register (0x24). Pin based configuration is defined as follows:

- BISTEN: Enable the BIST Process
- GPIO0 and GPIO1: Defines the BIST clock source (PCLK vs. various frequencies of internal OSC

DESERIALIZER GPIO[0:1]	OSCILLATOR SOURCE	BIST FREQUENCY (MHZ)
00	External PCLK	PCLK or External Oscillator
01	Internal	50
10	Internal	25
11	Internal	12.5

Table 6. BIST Configuration

The BIST mode provides various options for source PCLK. Using external pins, GPIO0 and GPIO1 or using registers, customer can program the BIST mode to use external PCLK or various OSC frequencies. The BIST status can be monitored real time on PASS pin. For every frame with error(s), PASS pin toggles low for half PCLK period. If two consecutive frames have errors, PCLK will toggle twice to allow counting of frames with errors. Once the BIST is done, the PASS pin reflects the pass/fail status of the last BIST run. The status can also be read through I²C for the number of frames in errors. BIST status on PASS pin remains until it is changed by a new BIST session or a reset. The BIST status on PASS pin is not maintained till RX loses LOCK after BISTEN is deassserted. To evaluate BIST in the external oscillator mode, both external oscillator and PCLK need to be present.

The BIST status on PASS pin is not maintained till RX loses LOCK after BISTEN is deassserted. So for all practical purposes, the BIST status can be monitored from register 0x25, that is, BIST Error Count on the DS90UB914Q-Q1 deserializer. To evaluate BIST in the external oscillator mode, both external oscillator and PCLK need to be present.

10.4.11.1 Sample BIST Sequence

Step 1. For the DS90UB91xQ-Q1 FPD-Link III chipset, BIST Mode is enabled through the BISTEN pin of DS90UB914Q-Q1 FPD-Link III deserializer. The desired clock source is selected through the GPIO0 and GPIO1 pins as shown in Table 4.

Step 2. The DS90UB913Q-Q1 serializer is woken up through the back channel if it is not already on. The SSO pattern on the data pins is send through the FPD-Link III to the deserializer. Once the serializer and deserializer are in the BIST mode and the deserializer acquires Lock, the PASS pin of the deserializer goes high and BIST starts checking data stream. If an error in the payload is detected the PASS pin will switch low for one half of the clock period. During the BIST test, the PASS output can be monitored and counted to determine the payload error rate.

Step 3. To stop the BIST mode, the deserializer BISTEN pin is set low. The deserializer stops checking the data. The final test result is not maintained on the PASS pin. To monitor the BIST status, check the BIST Error Count register, 0x25 on the deserializer.

Step 4. The link returns to normal operation after the deserailzer BISTEN pin is low. Figure 44 shows the waveform diagram of a typical BIST test for two cases. Case 1 is error free, and Case 2 shows one with multiple errors. In most cases, it is difficult to generate errors due to the robustness of the link (differential data transmission, and so forth), thus they may be introduced by greatly extending the cable length, faulting the interconnect, or by reducing signal condition enhancements (RX equalization).

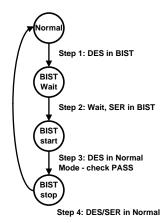


Figure 43. AT-Speed BIST System Flow Diagram

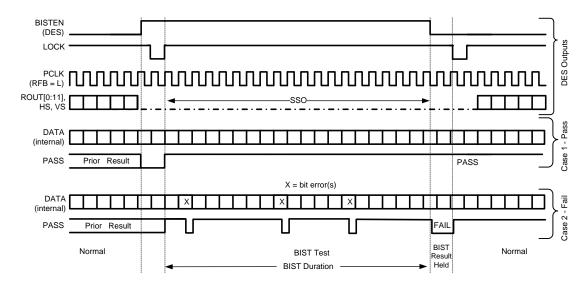


Figure 44. BIST Timing Diagram



10.5 Register Maps

Table 7. DS90UB913Q-Q1 Control Registers

ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
0x00	I ² C Device ID	7:1	DEVICE ID	RW	0x58'h	7-bit address of serializer; 0x58'h (0101_1000X'b) default
		0	SER ID SEL			0: Device ID is from ID[x] 1: Register I ² C Device ID overrides ID[x]
		7	RSVD			Reserved
		6	RDS	RW	0	Digital Output Drive Strength 1: High Drive Strength 0: Low Drive Strength
		5	VDDIO Control	RW	1	Auto Voltage Control 1: Enable 0: Disable
		4	VDDIO MODE	RW	1	V _{DDIO} Voltage set 0: 1.8V 1: 3.3V
0x01	Power and Reset	3	ANAPWDN	RW	0	This register can be set only through local I ² C access 1: Analog power-down: Powers Down the analog block in the serializer 0: No effect
		2	RSVD	RW	0	Reserved
		1	DIGITAL RESET1	RW	0	Resets the digital block except for register values values. Does not affect device I ² C Bus or Device ID. This bit is self-clearing. Normal Operation
		0	DIGITAL RESETO	RW	1	Digital Reset, resets the entire digital block including all register values. This bit is self-clearing. Normal Operation.
0x02				I	RESERVED	
		7	RX CRC Checker Enable	RW	1	Back-channel CRC Checker Enable 1:Enabled 0:Disabled
		6	TX Parity Generator Enable	RW	1	Forward channel Parity Generator Enable 1: Enable 0: Disable
		5	CRC Error Reset	RW	0	Clear CRC Error Counters. This bit is NOT self-clearing. 1: Clear Counters 0: Normal Operation
0x03	General Configuration	4	I ² C Remote Write Auto Acknowledge	RW	0	Automatically Acknowledge I ² C Remote Write The mode works when the system is LOCKed. 1: Enable: When enabled, I ² C writes to the deserializer (or any remote I ² C Slave, if I ² C PASS ALL is enabled) are immediately acknowledged without waiting for the deserializer to acknowledge the write. The accesses are then re-mapped to address specified in 0x06. 0: Disable
		3	I ² C Pass All	RW	0	1: Enable Forward Control Channel pass-through of all I ² C accesses to I ² C Slave IDs that do not match the Serializer I ² C Slave ID. The I ² C accesses are then remapped to address specified in register 0x06. 0: Enable Forward Control Channel pass-through only of I ² C accesses to I ² C Slave IDs matching either the remote Deserializer Slave ID or the remote Slave ID.
		2	I ² C PASSTHROUGH	RW	1	I ² C Pass-Through Mode 0: Pass-Through Disabled 1: Pass-Through Enabled



ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
0x03	0x03 General Configuration	1	OV_CLK2PLL	RW	0	1:Enabled: When enabled this registers overrides the clock to PLL mode (External Oscillator mode or Direct PCLK mode) defined through MODE pin and allows selection through register 0x35 in the serializer 0: Disabled: When disabled, Clock to PLL mode (External Oscillator mode or Direct PCLK mode) is defined through MODE pin on the serializer.
		0	TRFB	RW	1	Pixel Clock Edge Select 1: Parallel Interface Data is strobed on the Rising Clock Edge. 0: Parallel Interface Data is strobed on the Falling Clock Edge.
0x04			-		RESERVED	
		7	RSVD	RW	0	Reserved
		6	RSVD	RW	0	Reserved.
		5	MODE_OVERRIDE	RW	0	Allows overriding mode select bits coming from back- channel 1: Overrides MODE select bits 0: Does not override MODE select bits
0x05	Mode Select	4	MODE_UP To DATE	R	0	Indicates that the status of mode select from deserializer is up to date
		3	Pin_MODE_12-bit High Frequency	R	0	1: 12-bit high-frequency mode is selected. 0: 12-bit high-frequency mode is not selected.
		2	Pin_MODE_10-bit mode	R	0	1: 10-bit mode is selected. 0: 10-bit mode is not selected.
		1:0	RSVD			Reserved
0x06	DES ID	7:1	Desializer Device ID	RW	0x00	7-bit Deserializer Device ID configures the I ² C Slave ID of the remote deserializer. A value of 0 in this field disables I ² C access to the remote deserializer. This field is automatically configured by the Bidirectional Control Channel once RX Lock has been detected. Software may overwrite this value, but should also assert the FREEZE DEVICE ID bit to prevent overwriting by the Bidirectional Control Channel.
		0	Freeze Device ID	RW	0	1: Prevents auto-loading of the Deserializer Device ID by the bidirectional control channel. The ID will be frozen at the value written. 0: Update
0x07	DESAlias	7:1	Deserializer ALIAS ID	RW	0	7-bit Remote Deserializer Device Alias ID Configures the decoder for detecting transactions designated for an I ² C deserializer device. The transaction will be remapped to the address specified in the DES ID register. A value of 0 in this field disables access to the remote I ² C Slave.
		0	RSVD			Reserved
0x08	SlavelD	7:1	SLAVE ID	RW	0x00	7-bit Remote Slave Device ID Configures the physical I ² C address of the remote I ² C Slave device attached to the remote deserializer. If an I ² C transaction is addressed to the Slave Alias ID, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the deserializer. A value of 0 in this field disables access to the remote I ² C slave.
		0	RSVD			Reserved
			·			+



ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
0x09	SlaveAlias	7:1	SLAVE ALIAS ID	RW	0x00	7-bit Remote Slave Device Alias ID Configures the decoder for detecting transactions designated for an I ² C Slave device attached to the remote deserializer. The transaction will be remapped to the address specified in the Slave ID register. A value of 0 in this field disables access to the remote I ² C Slave.
		0	RSVD			Reserved
0x0A	CRC Errors	7:0	CRC Error Byte 0	R	0	Number of back-channel CRC errors during normal operation. Least Significant byte
0x0B	CRC Errors	7:0	CRC Error Byte 1	R	0	Number of back-channel CRC errors during normal operation. Most Significant byte
		7:5	Rev-ID	R	0	Revision ID 0x00: Production
		4	RX Lock Detect	R	0	1: RX LOCKED 0: RX not LOCKED
		3	BIST CRC Error Status	R	0	1: CRC errors in BIST mode 0: No CRC errors in BIST mode
		2	PCLK Detect	R	0	1: Valid PCLK detected 0: Valid PCLK not detected
0x0C Gene	General Status	1	DES Error	R	0	CRC error is detected during communication with deserializer. This bit is cleared upon loss of link or assertion of CRC ERROR RESET in register 0x04. No effect
		0	LINK Detect	R	0	1: Cable link detected 0: Cable link not detected This includes any of the following faults — Cable Open — + and - shorted — Short to GND — Short to battery
		7	GPO1 Output Value	RW	0	Local GPIO Output Value This value is output on the GPIO pin when the GPIO function is enabled, the local GPIO direction is Output, and remote GPIO control is disabled.
		6	GPO1 Remote Enable	RW	1	Remote GPIO Control 1: Enable GPIO control from remote deserializer. The GPIO pin needs to be an output, and the value is received from the remote deserializer. 0: Disable GPIO control from remote deserializer.
		5	GPO1 Direction	RW	0	1: Input 0: Output
000	GPO[0]	4	GPO0 Enable	RW	1	1: GPIO enable 0: Tri-state
0x0D	and GPO[1] Configuration	3	GPO0 Output Value	RW	0	Local GPIO Output Value This value is output on the GPIO pin when the GPIO function is enabled, the local GPIO direction is Output, and remote GPIO control is disabled.
		2	GPO0 Remote Enable	RW	1	Remote GPIO Control 1: Enable GPIO control from remote deserializer. The GPIO pin needs to be an output, and the value is received from the remote deserializer. 0: Disable GPIO control from remote deserializer.
		1	GPO0 Direction	RW	0	1: Input 0: Output
		0	GPO0 Enable	RW	1	1: GPIO enable 0: Tri-state



ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
		7	GPO3 Output Value	RW	0	Local GPIO Output Value This value is output on the GPIO pin when the GPIO function is enabled, the local GPIO direction is Output, and remote GPIO control is disabled.
		6	GPO3 Remote Enable	RW	0	Remote GPIO Control 1: Enable GPIO control from remote deserializer. The GPIO pin needs to be an output, and the value is received from the remote deserializer. 0: Disable GPIO control from remote deserializer.
		5	GPO3 Direction	RW	1	1: Input 0: Output
0.05	GPO[2]	4	GPO3 Enable	RW	1	1: GPIO enable 0: Tri-state
0x0E	and GPO[3] Configuration	3	GPO2 Output Value	RW	0	Local GPIO Output Value This value is output on the GPIO pin when the GPIO function is enabled, the local GPIO direction is Output, and remote GPIO control is disabled.
		2	GPO2 Remote Enable	RW	1	Remote GPIO Control 1: Enable GPIO control from remote deserializer. The GPIO pin needs to be an output, and the value is received from the remote deserializer. 0: Disable GPIO control from remote deserializer.
		1	GPO2 Direction	RW	0	1: Input 0: Output
		0	GPO2 Enable	RW	1	1: GPIO enable 0: Tri-state
		7:5	RSVD			Reserved
		4:3	SDA Output Delay	RW	00	SDA Output Delay This field configures output delay on the SDA output. Setting this value will increase output delay in units of 50 ns. Nominal output delay values for SCL to SDA are: 00 : 350 ns 01: 400 ns 10: 450 ns 11: 500 ns
0x0F	I ² C Master Config	2	Local Write Disable	RW	0	Disable Remote Writes to Local Registers Setting this bit to a 1 will prevent remote writes to local device registers from across the control channel. This prevents writes to the serializer registers from an I ² C master attached to the deserializer. Setting this bit does not affect remote access to I ² C slaves at the serializer.
		1	I ² C Bus Timer Speed up	RW	0	Speed up I ² C Bus Watchdog Timer 1: Watchdog Timer expires after approximately 50 microseconds 0: Watchdog Timer expires after approximately 1 second.
		0	I ² C Bus Timer Disable	RW	0	1. Disable I ² C Bus Watchdog Timer When the I ² C Watchdog Timer may be used to detect when the I ² C bus is free or hung up following an invalid termination of a transaction. If SDA is high and no signaling occurs for approximately 1 second, the I ² C bus will assumed to be free. If SDA is low and no signaling occurs, the device will attempt to clear the bus by driving 9 clocks on SCL 0: No effect



ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
		7	RSVD			Reserved
0x10	I ² C Control	6:4	SDA Hold Time	RW	0x1	Internal SDA Hold Time. This field configures the amount of internal hold time provided for the SDA input relative to the SCL input. Units are 50 ns.
		3:0	I ² C Filter Depth	RW	0x7	I ² C Glitch Filter Depth This field configures the maximum width of glitch pulses on the SCL and SDA inputs that will be rejected. Units are 10 ns.
0x11	SCL High Time	7:0	SCL High Time	RW	0x82	l ² C Master SCL High Time This field configures the high pulse width of the SCL output when the serializer is the Master on the local l ² C bus. Units are 50 ns for the nominal oscillator clock frequency. The default value is set to provide a minimum (4µs + 1µs of rise time for cases where rise time is very fast) SCL high time with the internal oscillator clock running at 26MHz rather than the nominal 20 MHz.
0x12	SCL LOW Time	7:0	SCL Low Time	RW	0x82	I^2C SCL Low Time This field configures the low pulse width of the SCL output when the serializer is the Master on the local I^2C bus. This value is also used as the SDA setup time by the I^2C Slave for providing data prior to releasing SCL during accesses over the Bidirectional Control Channel. Units are 50 ns for the nominal oscillator clock frequency. The default value is set to provide a minimum (4.7 μs + 0.3 μs of fall time for cases where fall time is very fast) SCL low time with the internal oscillator clock running at 26 MHz rather than the nominal 20 MHz.
0x13	General-Purpose Control	7:0	GPCR[7:0]	RW	0	1: High 0: Low
		7:3	RSVD			Reserved
0x14	BIST Control	2:1	Clock Source	RW	0x0	Allows choosing different OSC clock frequencies for forward channel frame. OSC Clock Frequency in Functional Mode when OSC mode is selected or when the selected clock source is not present, for example, missing PCLK/ External Oscillator. See Table 9 for oscillator clock frequencies when PCLK/ External Clock is missing.
		0	BIST Enable	RW	0	BIST Control: 1: Enable BIST mode 0: Disable BIST mode
0x15 - 0x1D					RESERVED	
0x1E	BCC Watchdog Control	7:1	BCC Watchdog Timer	RW	0x7F	The watchdog timer allows termination of a control channel transaction if it fails to complete within a programmed amount of time. This field sets the Bidirectional Control Channel Watchdog Timeout value in units of 2ms. This field should not be set to 0.
		0	BCC Watchdog Timer Disable	RW	0	Disable Bidirectional Control Channel Watchdog Timer 1: Disables BCC Watchdog Timer operation 0: Enables BCC Watchdog Timer operation
0x1F- 0x29					RESERVED	
0x2A	CRC Errors	7:0	BIST Mode CRC Errors Count	R	0	Number of CRC Errors in the back channel when in BIST mode



Table 7. DS90UB913Q-Q1 Control Registers (continued)

ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION			
0x2B - 0x34	RESERVED								
		7:4	RSVD			Reserved			
		3	PIN_LOCK to External Oscillator	RW	0	Status of mode select pin 1: Indicates External Oscillator mode is selected by mode-resistor 0: External Oscillator mode is not selected by mode- resistor			
0x35	PLL Clock Overwrite	2	PIN_LOCK to Oscillator	RW	0	Status of mode select pin 1: Indicates PCLK mode is selected by mode-resistor 0: PCLK mode not selected by mode-resistor			
		1	LOCK to External Oscillator	RW	0	Affects only when 0x03[1]=1 (OV_CLK2PLL) and 0x35[0]=0. 1: Routes GPO3 directly to PLL 0: Allows PLL to lock to PCLK"			
		0	RSVD			Reserved			

Table 8. DS90UB914Q-Q1 Control Registers

ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
		7:1	DEVICE ID	RW	0x60'h	7-bit address of deserializer; 0x60h
0x00	I ² C Device ID	0	Deserializer ID Select	RW	0	O: Deserializer Device ID is set using address coming from CAD Register I ² C Device ID overrides ID[x]
		7:6	RSVD			Reserved
		5	ANAPWDN	RW	0	This register can be set only through local I ² C access 1: Analog power-down: Powers down the analog block in the serializer 0: No effect
		4:2	RSVD			Reserved
0x01	Reset	1	Digital Reset 1	RW	0	Digital Reset Resets the entire digital block except registers. This bit is self-clearing. 1: Reset 0: No effect
		0	Digital Reset 0	RW	0	Digital Reset Resets the entire digital block including registers. This bit is self-clearing. 1: Reset 0: No effect



ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
		7	RSVD RSVD			Reserved
		5	Auto-Clock	RW	0	Reserved 1: Output PCLK or OSC clock when not LOCKED 0: Only PCLK
		4	SSCG LFMODE	RW	0	1: Selects 8x mode for 10-18 MHz frequency range in SSCG 0: SSCG running at 4X mode
0x02	General Configuration 0	3:0	SSCG	RW	0	SSCG Select 0000: Normal Operation, SSCG OFF 0001: fmod (kHz) PCLK/2168, fdev ±0.50% 0010: fmod (kHz) PCLK/2168, fdev ±1.00% 0011: fmod (kHz) PCLK/2168, fdev ±1.50% 0100: fmod (kHz) PCLK/2168, fdev ±2.00% 0101: fmod (kHz) PCLK/1300, fdev ±0.50% 0110: fmod (kHz) PCLK/1300, fdev ±1.00% 0111: fmod (kHz) PCLK/1300, fdev ±1.50% 1000: fmod (kHz) PCLK/1300, fdev ±1.50% 1001: fmod (kHz) PCLK/1300, fdev ±2.00% 1001: fmod (kHz) PCLK/868, fdev ±0.50% 1010: fmod (kHz) PCLK/868, fdev ±1.00% 1011: fmod (kHz) PCLK/868, fdev ±0.50% 1101: fmod (kHz) PCLK/869, fdev ±0.50% 1101: fmod (kHz) PCLK/650, fdev ±0.50% 1111: fmod (kHz) PCLK/650, fdev ±1.00% Note: This register should be changed only after disabling SSCG.
		7	RX Parity Checker Enable	RW	1	Forward-Channel Parity Checker Enable 1: Enable 0: Disable
	General	6	TX CRC Checker Enable	RW	1	Back-Channel CRC Generator Enable 1: Enable 0: Disable
0x03	Configuration 1	5	V _{DDIO} Control	RW	1	Auto voltage control 1: Enable (auto-detect mode) 0: Disable
		4	V _{DDIO} Mode	RW	0	VDDIO voltage set 1: 3.3 V 0: 1.8 V
		3	I ² C Passthrough	RW	1	I ² C Pass-Through Mode 1: Pass-Through Enabled 0: Pass-Through Disabled
0x03	0x03 General Configuration 1	2	AUTO ACK	RW	0	Automatically Acknowledge I ² C Remote Write When enabled, I ² C writes to the deserializer (or any remote I ² C Slave, if I ² C PASS ALL is enabled) are immediately acknowledged without waiting for the deserializer to acknowledge the write. The accesses are then remapped to address specified in 0x06. This allows I ² C bus without LOCK. 1: Enable 0: Disable
		1	Parity Error Reset	RW	0	Parity Error Reset, This bit is self-clearing. 1: Parity Error Reset 0: No effect
		0	RRFB	RW	1	Pixel Clock Edge Select 1: Parallel Interface Data is strobed on the Rising Clock Edge. 0: Parallel Interface Data is strobed on the Falling Clock Edge.



ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
0x04	EQ Feature Control 1	7:0	EQ level - when AEQ bypass is enabled EQ setting is provided by this register	RW	0x00	Equalization gain 0x00 = ~0.0 dB 0x01 = ~4.5 dB 0x03 = ~6.5 dB 0x07 = ~7.5 dB 0x0F = ~8.0 dB 0x1F = ~11.0 dB 0x3F = ~12.5 dB
0x05				RES	SERVED	
		7:1	Remote ID	RW	0x0C	Remote Serializer ID
0x06	SER ID	0	Freeze Device ID	RW	0	Freeze Serializer Device ID Prevent autoloading of the serializer Device ID from the Forward Channel. The ID will be frozen at the value written.
0x07	SER Alias	7:1	Serializer Alias ID	RW	0x00	7-bit Remote Serializer Device Alias ID Configures the decoder for detecting transactions designated for an I ² C deserializer device. The transaction will be remapped to the address specified in the SER ID register. A value of 0 in this field disables access to the remote I ² C Slave.
		0	RSVD			Reserved
0x08	Slave ID[0]	7:1	Slave ID0	RW	0	7-bit Remote Slave Device ID 0 Configures the physical I ² C address of the remote I ² C Slave device attached to the remote serializer. If an I ² C transaction is addressed to the Slave Alias ID0, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the serializer.
		0	RSVD			Reserved
0x09	Slave ID[1]	7:1	Slave ID1	RW	0	7-bit Remote Slave Device ID 1 Configures the physical I ² C address of the remote I ² C Slave device attached to the remote serializer. If an I ² C transaction is addressed to the Slave Alias ID1, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the serializer.
		0	RSVD			Reserved
0x0A	Slave ID[2]	7:1	Slave ID2	RW	0x00	7-bit Remote Slave Device ID 2 Configures the physical I ² C address of the remote I ² C Slave device attached to the remote serializer. If an I ² C transaction is addressed to the Slave Alias ID2, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the serializer.
		0	RSVD			Reserved
0x0B	Slave ID[3]	7:1	Slave ID3	RW	0	7-bit Remote Slave Device ID 3 Configures the physical I ² C address of the remote I ² C Slave device attached to the remote serializer. If an I ² C transaction is addressed to the Slave Alias ID3, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the serializer.
		0	RSVD			Reserved



ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
0x0C	Slave ID[4]	7:1	Slave ID4	RW	0	7-bit Remote Slave Device ID 4 Configures the physical I ² C address of the remote I ² C Slave device attached to the remote serializer. If an I ² C transaction is addressed to the Slave Alias ID4, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the serializer.
		0	RSVD			Reserved
0x0D	Slave ID[5]	7:1	Slave ID5	RW	0x00	7-bit Remote Slave Device ID 5 Configures the physical I ² C address of the remote I ² C Slave device attached to the remote serializer. If an I ² C transaction is addressed to the Slave Alias ID5 , the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the serializer.
		0	RSVD			Reserved
0x0E	Slave ID[6]	7:1	Slave ID6	RW	0	7-bit Remote Slave Device ID 6 Configures the physical I ² C address of the remote I ² C Slave device attached to the remote serializer. If an I ² C transaction is addressed to the Slave Alias ID6, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the serializer.
		0	RSVD			Reserved
0x0F	Slave ID[7]	7:1	Slave ID7	RW	0x00	7-bit Remote Slave Device ID 7 Configures the physical I ² C address of the remote I ² C Slave device attached to the remote serializer. If an I ² C transaction is addressed to the Slave Alias ID7, the transaction will be remapped to this address before passing the transaction across the Bidirectional Control Channel to the serializer.
		0	RSVD			Reserved
0x10	Slave Alias[0]	7:1	Slave Alias ID0	RW	0x00	7-bit Remote Slave Device Alias ID 0 Configures the decoder for detecting transactions designated for an I ² C Slave device attached to the remote serializer. The transaction will be remapped to the address specified in the Slave ID0 register. A value of 0 in this field disables access to the remote I ² C Slave.
		0	RSVD			Reserved
0x11	Slave Alias[1]	7:1	Slave Alias ID1	RW	0x00	7-bit Remote Slave Device Alias ID 1 Configures the decoder for detecting transactions designated for an I ² C Slave device attached to the remote serializer. The transaction will be remapped to the address specified in the Slave ID1 register. A value of 0 in this field disables access to the remote I ² C Slave.
		0	RSVD			Reserved



ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
0x12	Slave Alias[2]	7:1	Slave Alias ID2	RW	0x00	7-bit Remote Slave Device Alias ID 2 Configures the decoder for detecting transactions designated for an I ² C Slave device attached to the remote serializer. The transaction will be remapped to the address specified in the Slave ID2 register. A value of 0 in this field disables access to the remote I ² C Slave.
		0	RSVD			Reserved
0x13	Slave Alias[3]	7:1	Slave Alias ID3	RW	0x00	7-bit Remote Slave Device Alias ID 3 Configures the decoder for detecting transactions designated for an I ² C Slave device attached to the remote serializer. The transaction will be remapped to the address specified in the Slave ID3 register. A value of 0 in this field disables access to the remote I ² C Slave.
		0	RSVD			Reserved
0x14	Slave Alias[4]	7:1	Slave Alias ID4	RW	0x00	7-bit Remote Slave Device Alias ID 4 Configures the decoder for detecting transactions designated for an I ² C Slave device attached to the remote serializer. The transaction will be remapped to the address specified in the Slave ID4 register. A value of 0 in this field disables access to the remote I ² C Slave.
		0	RSVD			Reserved
0x15	Slave Alias[5]	7:1	Slave Alias ID5	RW	0x00	7-bit Remote Slave Device Alias ID 5 Configures the decoder for detecting transactions designated for an I ² C Slave device attached to the remote serializer. The transaction will be remapped to the address specified in the Slave ID5 register. A value of 0 in this field disables access to the remote I ² C Slave.
		0	RSVD			Reserved
0x16	Slave Alias[6]	7:1	Slave Alias ID6	RW	0x00	7-bit Remote Slave Device Alias ID 6 Configures the decoder for detecting transactions designated for an I ² C Slave device attached to the remote serializer. The transaction will be remapped to the address specified in the Slave ID6 register. A value of 0 in this field disables access to the remote I ² C Slave.
		0	RSVD			Reserved
0x17	Slave Alias[7]	7:1	Slave Alias ID7	RW	0x00	7-bit Remote Slave Device Alias ID 7 Configures the decoder for detecting transactions designated for an I ² C Slave device attached to the remote serializer. The transaction will be remapped to the address specified in the Slave ID7 register. A value of 0 in this field disables access to the remote I ² C Slave.
		0	RSVD			Reserved
0x18	Parity Errors Threshold	7:0	Parity Error Threshold Byte 0	RW	0	Parity errors threshold on the Forward channel during normal information. This sets the maximum number of parity errors that can be counted using register 0x1A. Least significant Byte.



ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
0x19	Parity Errors Threshold	7:0	Parity Error Threshold Byte 1	RW	0	Parity errors threshold on the Forward channel during normal operation. This sets the maximum number of parity errors that can be counted using register 0x1B. Most significant Byte
0x1A	Parity Errors	7:0	Parity Error Byte 0	RW	0	Number of parity errors in the Forward channel during normal operation. Least significant Byte
0x1B	Parity Errors	7:0	Parity Error Byte 1	RW	0	Number of parity errors in the Forward channel during normal operation Most significant Byte
		7:4	Rev-ID	R	0	Revision ID 0x0000: Production
		3	RSVD			Reserved
0x1C General Status	General Status	2	Parity Error	R	0	Parity Error detected 1: Parity Errors detected 0: No Parity Errors
	1	Signal Detect	R	0	Serial input detected Serial input not detected	
		0	Lock	R	0	Deserializer CDR, PLL's clock to recovered clock frequency 1: Deserializer locked to recovered clock 0: Deserializer not locked
		7	GPIO1 Output Vaue	RW	0	Local GPIO Output Value This value is the output on the GPIO pin when the GPIO function is enabled, the local GPIO direction is Output.
		6	RSVD			Reserved
0x1D	GPIO[1] and GPIO[0] Config	5	GPIO1 Direction	RW	1	Local GPIO Direction 1: Input 0: Output
	Of fo[o] coming	4	GPIO1 Enable	RW	1	GPIO Function Enable 1: Enable GPIO operation 0: Enable normal operation
		3	GPIO0 Output Value	RW	0	Local GPIO Output Value This value is output on the GPIO pin when the GPIO function is enabled, the local GPIO direction is Output.
		2	RSVD			Reserved
0x1D	GPIO[1] and GPIO[0] Config	1	GPIO0 Direction	RW	1	Local GPIO Direction 1: Input 0: Output
	S. Totol doming	0	GPIO0 Enable	RW	1	GPIO Function Enable 1: Enable GPIO operation 0: Enable normal operation



ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
		7	GPIO3 Output Vaue	RW	0	Local GPIO Output Value This value is the output on the GPIO pin when the GPIO function is enabled, the local GPIO direction is Output.
		6	RSVD			Reserved
		5	GPIO3 Direction	RW	1	Local GPIO Direction 1: Input 0: Output
0x1E	GPIO[3] and	4	GPIO3 Enable	RW	1	GPIO Function Enable 1: Enable GPIO operation 0: Enable normal operation
OXIL	GPIO[2] Config	3	GPIO2 Output Value	RW	0	Local GPIO Output Value This value is output on the GPIO pin when the GPIO function is enabled, the local GPIO direction is Output.
		2	RSVD			Reserved
		1	GPIO2 Direction	RW	1	Local GPIO Direction 1: Input 0: Output
			GPIO2 Enable	RW	1	GPIO Function Enable 1: Enable GPIO operation 0: Enable normal operation
		7	OEN_OSS Override	RW	0	Allows overriding OEN and OSS select coming from Pins 1: Overrides OEN/OSS_SEL selected by pins 0: Does NOT override OEN/OSS_SEL select by pins
			OEN Select	RW	0	OEN configuration from register
		5	OSS Select	R	0	OSS_SEL configuration from register
		4	MODE_OVERRIDE	RW	0	Allows overriding mode select bits coming from back-channel 1: Overrides MODE select bits 0: Does not override MODE select bits
0x1F	Mode and OSS Select	3	PIN_MODE_12-bit HF mode	R	0	Status of mode select pin
		2	PIN_MODE_10-bit mode	R	0	Status of mode select pin
		1	MODE_12-bit High Frequency	RW	0	Selects 12-bit high-frequency mode. This bit is automatically updated by the mode settings from RX unless MODE_OVERRIDE is SET 1: 12-bit high-frequency mode is selected. 0: 12-bit high-frequency mode is not selected.
		0	MODE_10-bit mode	RW	0	Selects 10-bit mode. This bit is automatically updated by the mode settings from RX unless MODE_OVERRIDE is SET 1: Enables 10-bit mode. 0: Disables 10-bit mode.
0x20	BCC Watchdog Control	7:1	BCC Watchdog timer	RW	0	The watchdog timer allows termination of a control channel transaction if it fails to complete within a programmed amount of time. This field sets the Bidirectional Control Channel Watchdog Timeout value in units of 2ms. This field should not be set to 0.
		0	BCC Watchdog Timer Disable	RW	0	Disable Bidirectional Control Channel Watchdog Timer 1: Disables BCC Watchdog Timer operation 0: Enables BCC Watchdog Timer operation



ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
		7	I ² C pass-through all	RW	0	I ² C Pass-Through All Transactions 0: Disabled 1: Enabled
0x21	I ² C Control 1	6:4	I ² C SDA Hold	RW	0	Internal SDA Hold Time This field configures the amount of internal hold time provided for the SDA input relative to the SCL input. Units are 50ns.
		3:0	I ² C Filter Depth	RW	0	I ² C Glitch Filter Depth This field configures the maximum width of glitch pulses on the SCL and SDA inputs that will be rejected. Units are 10ns.
		7	Forward Channel Sequence Error	R	0	Control Channel Sequence Error Detected This bit indicates a sequence error has been detected in forward control channel. 1: If this bit is set, an error may have occurred in the control channel operation 0: No forward channel errors have been detected on the control channel
		6	Clear Sequence Error	RW	0	Clears the Sequence Error Detect bit
		5	RSVD			Reserved
		4:3 SDA C		RW	0	SDA Output Delay This field configures output delay on the SDA output. Setting this value will increase output delay in units of 50 ns. Nominal output delay values for SCL to SDA are: 00 : 350ns 01: 400ns 10: 450ns 11: 500ns
0x22	0x22 I ² C Control 2		Local Write Disable	RW	0	Disable Remote Writes to local registers Setting this bit to a 1 will prevent remote writes to local device registers from across the control channel. This prevents writes to the deserializer registers from an I ² C master attached to the serializer. Setting this bit does not affect remote access to I ² C slaves at the deserializer.
		1	I ² C Bus Timer Speed up	RW	0	Speed up I ² C Bus Watchdog Timer 1: Watchdog Timer expires after approximately 50 µs 0: Watchdog Timer expires after approximately 1 s.
		0 I ² C Bus Timer Disable		RW	0	Disable I ² C Bus Watchdog Timer When the I ² C Watchdog Timer may be used to detect when the I ² C bus is free or hung up following an invalid termination of a transaction. If SDA is high and no signaling occurs for approximately 1 second, the I ² C bus will assumed to be free. If SDA is low and no signaling occurs, the device will attempt to clear the bus by driving 9 clocks on SCL
0x23	General-Purpose Control	7:0	GPCR	RW	0	Scratch Register
		7:4	RSVD			Reserved
0x24	BIST Control	3	BIST Pin Configuration	RW	1	Bist Configured through Pin. 1: Bist configured through pin. 0: Bist configured through register bit "reg_24[0]"
0,24	DIOT CONTION	2:1	BIST Clock Source	RW	00	BIST Clock Source See Table 10
		0	BIST Enable	RW	0	BIST Control 1: Enabled 0: Disabled



ADDR (HEX)	NAME	BITS	FIELD	R/W	DEFAULT	DESCRIPTION
0x25	Parity Error Count	7:0	BIST Error Count	R	0	Number of Forward channel Parity errors in the BIST mode.
0x26 - 0x3B				RES	SERVED	
		7:2	RSVD			Reserved
0x3C	Oscillator output divider select	1:0	OSC OUT DIVIDER SEL	RW	0	Selects the divider for the OSC clock out on PCLK when system is not locked and selected by OEN/OSSSEL 0x02[5] 00: 50M (± 30%) 01: 25M (± 30%) 1X: 12.5M (± 30%)
0x3D - 0x3E				RES	SERVED	
		7:5	RSVD			Reserved
0x3F	CML Output Enable	4	CML OUT Enable	RW	1	0: CML Loop-through Driver is powered up 1: CML Loop-through Driver is powered down.
		3:0	RSVD			Reserved
0x40	SCL High Time	7:0	SCL High Time	RW	0x82	I^2C Master SCL High Time This field configures the high pulse width of the SCL output when the deserializer is the Master on the local I^2C bus. Units are 50 ns for the nominal oscillator clock frequency. The default value is set to provide a minimum (4µs + 0.3µs of rise time for cases where rise time is very fast) SCL high time with the internal oscillator clock running at 26MHz rather than the nominal 20MHz.
0x41	SCL Low Time	7:0	SCL Low Time	RW	0x82	I ² C SCL Low Time This field configures the low pulse width of the SCL output when the deserializer is the Master on the local I ² C bus. This value is also used as the SDA setup time by the I ² C Slave for providing data prior to releasing SCL during accesses over the Bidirectional Control Channel. Units are 50 ns for the nominal oscillator clock frequency. The default value is set to provide a minimum (4.7µs + 0.3µs of fall time for cases where fall time is very fast) SCL low time with the internal oscillator clock running at 26MHz rather than the nominal 20MHz.
		7:2	RSVD			Reserved
0x42	CRC Force Error	1	Force Back Channel Error	RW	0	This bit introduces multiple errors into Back channel frame. No effect
		0	Force One Back Channel Error	RW	0	1: This bit introduces ONLY one error into Back channel frame. Self clearing bit 0: No effect
0x43 - 0x4C				RES	SERVED	
		7	RSVD			Reserved
0x4D	AEQ Test Mode Select	6	AEQ Bypass	RW	0	Bypass AEQ and use set manual EQ value using register 0x04
		5:0	RSVD			Reserved
0x4E	EQ Value	7:0	AEQ / Manual Eq Readback	R	0	Read back the adaptive and manual Equalization value





Table 9. Clock Sources for Forward Channel Frame on the Serializer During Normal Operation

DS90UB913Q REG 0x14 [2:1]	10-BIT MODE	12-BIT HIGH-FREQUENCY MODE	12-BIT LOW-FREQUENCY MODE
00	50 MHz	37.5 MHz	25 MHz
01	100 MHz	75 MHz	50 MHz
10	50 MHz	37.5 MHz	25 MHz
11	25MHz	18.75 MHz	12.5 MHz

Table 10. BIST Clock Sources

DS90UB914Q REG 0x24 [2:1]	10-BIT MODE	12-BIT HIGH-FREQUENCY MODE	12-BIT LOW-FREQUENCY MODE
00	PCLK	PCLK	PCLK
01	100 MHz	75 MHz	50 MHz
10	50 MHz	37.5 MHz	25 MHz
11	25MHz	18.75 MHz	12.5 MHz



11 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

11.1 Applications Information

The serializer and deserializer support only AC-coupled interconnects through an integrated DC-balanced decoding scheme. External AC-coupling capacitors must be placed in series in the FPD-Link III signal path as illustrated in Figure 45.

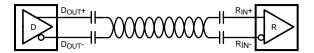


Figure 45. AC-Coupled Connection

For high-speed FPD-Link III transmissions, the smallest available package should be used for the AC-coupling capacitor. This will help minimize degradation of signal quality due to package parasitics. The I/Os require a 100-nF AC-coupling capacitors to the line.

11.2 Typical Application

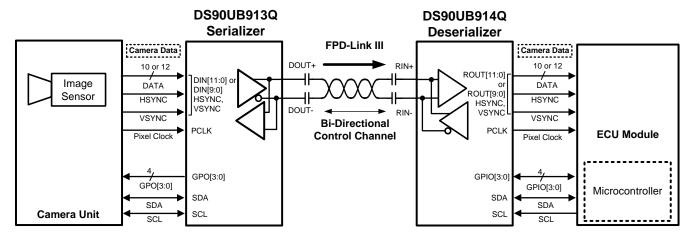


Figure 46. Application Block Diagram

11.2.1 Design Requirements

11.2.1.1 Transmission Media

The DS90UB91xQ-Q1 chipset is intended to be used in a point-to-point configuration through a shielded twisted pair cable. The serializer and deserializer provide internal termination to minimize impedance discontinuities. The interconnect (cable and connectors) should have a differential impedance of $100~\Omega$. The maximum length of cable that can be used is dependent on the quality of the cable (gauge, impedance), connector, board (discontinuities, power plane), the electrical environment (for example, power stability, ground noise, input clock jitter, PCLK frequency, and so forth). The resulting signal quality at the receiving end of the transmission media may be assessed by monitoring the differential eye opening of the serial data stream. A differential probe should be used to measure across the termination resistor at the CMLOUTP/N pins. Figure 20 illustrates the minimum eye width and eye height that is necessary for bit error free operation.



Typical Application (continued)

11.2.1.2 Adaptive Equalizer – Loss Compensation

The adaptive equalizer is designed to compensate for signal degradation due to the differential insertion loss of the interconnect components. There are limits to the amount of loss that can be compensated – these limits are defined by the gain curve of the equalizer. In addition, there is an inherent tolerance for loss defined by the delta between the minimum VDO of the serializer and the input threshold (Vswing) of the deserializer. In order to determine the maximum cable reach, other factors that affect signal integrity such as jitter, skew, ISI, crosstalk, and so forth, need to be taken into consideration. Figure 49 illustrates the maximum allowable interconnect loss with the adaptive equalizer at its maximum gain setting (914 equalizer gain).

11.2.2 Detailed Design Procedure

Figure 47 shows the typical connection of a DS90UB913Q-Q1 serializer.

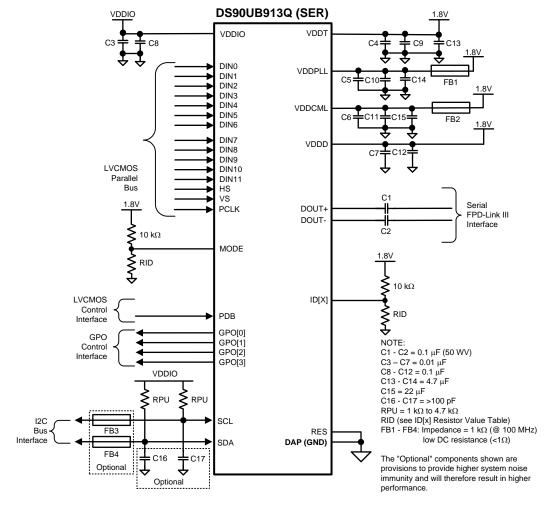
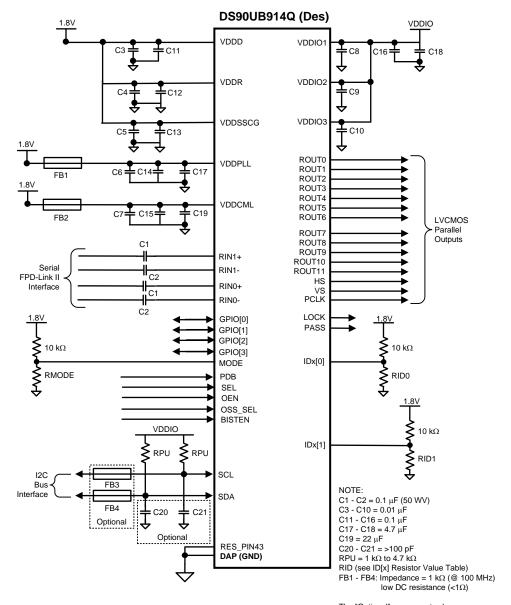


Figure 47. DS90UB913Q-Q1 Typical Connection Diagram — Pin Control



Typical Application (continued)

Figure 48 shows a typical connection of the DS90UB914Q-Q1 deserializer.



The "Optional" components shown are provisions to provide higher system noise immunity and will therefore result in higher performance.

Figure 48. DS90UB914Q-Q1 Typical Connection Diagram — Pin Control



Typical Application (continued)

11.2.3 Application Curve

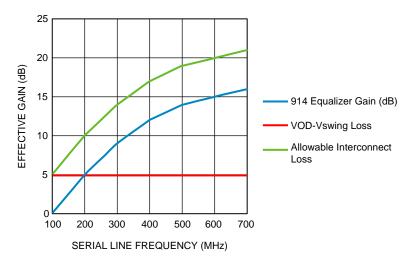


Figure 49. Adaptive Equalizer – Interconnect Loss Compensation



12 Power Supply Recommendations

This device is designed to operate from an input core voltage supply of 1.8 V. Some devices provide separate power and ground terminals for different portions of the circuit. This is done to isolate switching noise effects between different sections of the circuit. Separate planes on the PCB are typically not required. Terminal description tables typically provide guidance on which circuit blocks are connected to which power terminal pairs. In some cases, an external filter may be used to provide clean power to sensitive circuits such as PLLs.

13 Layout

13.1 Layout Guidelines

Printed-circuit-board layout and stack-up for the serializer and deserializer devices should be designed to provide low-noise power feed to the device. Good layout practice will also separate high frequency or high-level inputs and outputs to minimize unwanted stray noise pickup, feedback and interference. Power system performance may be greatly improved by using thin dielectrics (2 to 4 mils) for power/ground sandwiches. This arrangement provides plane capacitance for the PCB power system with low-inductance parasitics, which has proven especially effective at high frequencies, and makes the value and placement of external bypass capacitors less critical. External bypass capacitors should include both RF ceramic and tantalum electrolytic types. RF capacitors may use values in the range of 0.01 μ F to 0.1 μ F. Tantalum capacitors may be in the 2.2- μ F to 10- μ F range. Voltage rating of the tantalum capacitors should be at least 5x the power supply voltage being used.

Surface mount capacitors are recommended due to their smaller parasitics. When using multiple capacitors per supply pin, locate the smaller value closer to the pin. A large bulk capacitor is recommend at the point of power entry. This is typically in the 50-µF to 100-µF range and will smooth low frequency switching noise. It is recommended to connect power and ground pins directly to the power and ground planes with bypass capacitors connected to the plane with a via on both ends of the capacitor. Connecting power or ground pins to an external bypass capacitor will increase the inductance of the path.

A small body size X7R chip capacitor, such as 0603, is recommended for external bypass. Its small body size reduces the parasitic inductance of the capacitor. The user must pay attention to the resonance frequency of these external bypass capacitors, usually in the range of 20 to 30 MHz. To provide effective bypassing, multiple capacitors are often used to achieve low impedance between the supply rails over the frequency of interest. At high frequency, it is also a common practice to use two vias from power and ground pins to the planes, reducing the impedance at high frequency.

Some devices provide separate power for different portions of the circuit. This is done to isolate switching noise effects between different sections of the circuit. Separate planes on the PCB are typically not required. Pin description tables typically provide guidance on which circuit blocks are connected to which power pin pairs. In some cases, an external filter many be used to provide clean power to sensitive circuits such as PLLs.

Use at least a four-layer board with a power and ground plane. Locate LVCMOS signals away from the differential lines to prevent coupling from the LVCMOS lines to the differential lines. Closely-coupled differential lines of 100 Ω are typically recommended for differential interconnect. The closely coupled lines help to ensure that coupled noise will appear as common-mode and thus is rejected by the receivers. The tightly coupled lines will also radiate less.

Information on the WQFN style package is provided in Texas Instruments' Application Note: AN-1187 (SNOA401).

See AN-1108 (SNLA008) and AN-905 (SNLA035) for full details.

- Use 100-Ω coupled differential pairs
- Use the S, 2S, and 3S rule in spacings
 - S = space between the pair
 - 2S = space between pairs
 - 3S = space to LVCMOS signal
- Minimize the number of Vias
- Use differential connectors when operating above 500Mbps line speed
- Maintain balance of the traces
- Minimize skew within the pair



Layout Guidelines (continued)

Additional general guidance can be found in the LVDS Owner's Manual - available in PDF format from the Texas Instrument web site at: www.ti.com/lvds

13.2 Layout Example

Stencil parameters such as aperture area ratio and the fabrication process have a significant impact on paste deposition. Inspection of the stencil prior to placement of the WQFN package is highly recommended to improve board assembly yields. If the via and aperture openings are not carefully monitored, the solder may flow unevenly through the DAP. Stencil parameters for aperture opening and via locations are shown in Figure 50.

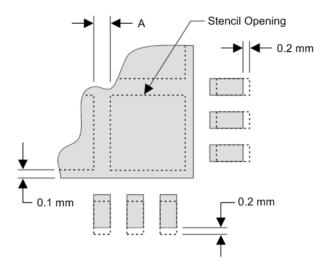


Figure 50. No Pullback WQFN, Single Row Reference Diagram

Figure 50 and Figure 51 PCB layout examples are derived from the layout design of the *DS90UB913Q-Q1* Serializer and *DS90UB914Q-Q1* Deserializer Evaluation Kit (SNLU110). These graphics and additional layout description are used to demonstrate both proper routing and proper solder techniques when designing in the serializer and deserializer.

Table 11. No Pullback WQFN Stencil Aperture Summary for DS90UB913Q-Q1 and DS90UB914Q-Q1

DEVICE	PIN COUNT	MKT DWG	PCB I/O PAD SIZE (mm)	PCB PITCH (mm)	PCB DAP SIZE (mm)	STENCIL I/O APERTURE (mm)	STENCIL DAP APERTURE (mm)	NUMBER OF DAP APERTURE OPENINGS	GAP BETWEEN DAP APERTURE (Dim A mm)
DS90UB913Q-Q1	32	RTV	0.25 x 0.6	0.5	3.1 x 3.1	0.25 x 0.7	1.4 x 1.4	4	0.2
DS90UB914Q-Q1	48	RHS	0.25 x 0.6	0.5	5.1 x 5.1	0.25 x 0.7	1.1 x 1.1	16	0.2



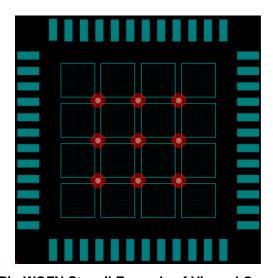


Figure 51. 48-Pin WQFN Stencil Example of Via and Opening Placement



14 器件和文档支持

14.1 文档支持

14.1.1 相关文档

相关文档如下:

- 《焊接相关的最大绝对额定值》, SNOA549
- AN-1187《无引线框架封装 (LLP)》, SNOA401
- *AN-1108*《通道链路 *PCB* 和互连设计指南》, SNLA008
- 《传输线路 RAPIDESIGNER 操作和应用指南》, SNLA035
- 《DS90UB913Q-Q1 串行器和 DS90UB914Q-Q1 解串器评估套件》, SNLU110

14.2 相关链接

以下表格列出了快速访问链接。 范围包括技术文档、支持与社区资源、工具和软件,并且可以快速访问样片或购买链接。

丰	12	相关链接
ハン	14.	加入班安

器件	产品文件夹	样片与购买	技术文档	工具与软件	支持与社区
DS90UB913Q-Q1	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处
DS90UB914Q-Q1	请单击此处	请单击此处	请单击此处	请单击此处	请单击此处

14.3 社区资源

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Lise

TI E2E™ Online Community TI's Engineer-to-Engineer (E2E) Community. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

14.4 商标

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

14.5 静电放电警告



这些装置包含有限的内置 ESD 保护。 存储或装卸时,应将导线一起截短或将装置放置于导电泡棉中,以防止 MOS 门极遭受静电损伤。

14.6 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

15 机械、封装和可订购信息

以下页中包括机械、封装和可订购信息。 这些信息是针对指定器件可提供的最新数据。 这些数据会在无通知且不 对本文档进行修订的情况下发生改变。 欲获得该数据表的浏览器版本,请查阅左侧的导航栏。





10-Dec-2020

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material			Device Marking (4/5)	Samples
	(-)					(=)	(6)	(=)		(/	
DS90UB913QSQ/NOPB	ACTIVE	WQFN	RTV	32	1000	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 105	UB913SQ	Samples
DS90UB913QSQE/NOPB	ACTIVE	WQFN	RTV	32	250	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 105	UB913SQ	Samples
DS90UB913QSQX/NOPB	ACTIVE	WQFN	RTV	32	4500	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 105	UB913SQ	Samples
DS90UB914QSQ/NOPB	ACTIVE	WQFN	RHS	48	1000	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 105	UB914QSQ	Samples
DS90UB914QSQE/NOPB	ACTIVE	WQFN	RHS	48	250	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 105	UB914QSQ	Samples
DS90UB914QSQX/NOPB	ACTIVE	WQFN	RHS	48	2500	RoHS & Green	SN	Level-3-260C-168 HR	-40 to 105	UB914QSQ	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



PACKAGE OPTION ADDENDUM

10-Dec-2020

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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS90UB913QSQ/NOPB	WQFN	RTV	32	1000	178.0	12.4	5.3	5.3	1.3	8.0	12.0	Q1
DS90UB913QSQE/NOPB	WQFN	RTV	32	250	178.0	12.4	5.3	5.3	1.3	8.0	12.0	Q1
DS90UB913QSQX/NOPB	WQFN	RTV	32	4500	330.0	12.4	5.3	5.3	1.3	8.0	12.0	Q1
DS90UB914QSQ/NOPB	WQFN	RHS	48	1000	330.0	16.4	7.3	7.3	1.3	12.0	16.0	Q1
DS90UB914QSQE/NOPB	WQFN	RHS	48	250	178.0	16.4	7.3	7.3	1.3	12.0	16.0	Q1
DS90UB914QSQX/NOPB	WQFN	RHS	48	2500	330.0	16.4	7.3	7.3	1.3	12.0	16.0	Q1



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*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS90UB913QSQ/NOPB	WQFN	RTV	32	1000	208.0	191.0	35.0
DS90UB913QSQE/NOPB	WQFN	RTV	32	250	208.0	191.0	35.0
DS90UB913QSQX/NOPB	WQFN	RTV	32	4500	356.0	356.0	36.0
DS90UB914QSQ/NOPB	WQFN	RHS	48	1000	356.0	356.0	36.0
DS90UB914QSQE/NOPB	WQFN	RHS	48	250	208.0	191.0	35.0
DS90UB914QSQX/NOPB	WQFN	RHS	48	2500	356.0	356.0	36.0





NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.





NOTES: (continued)

- 4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
- 5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



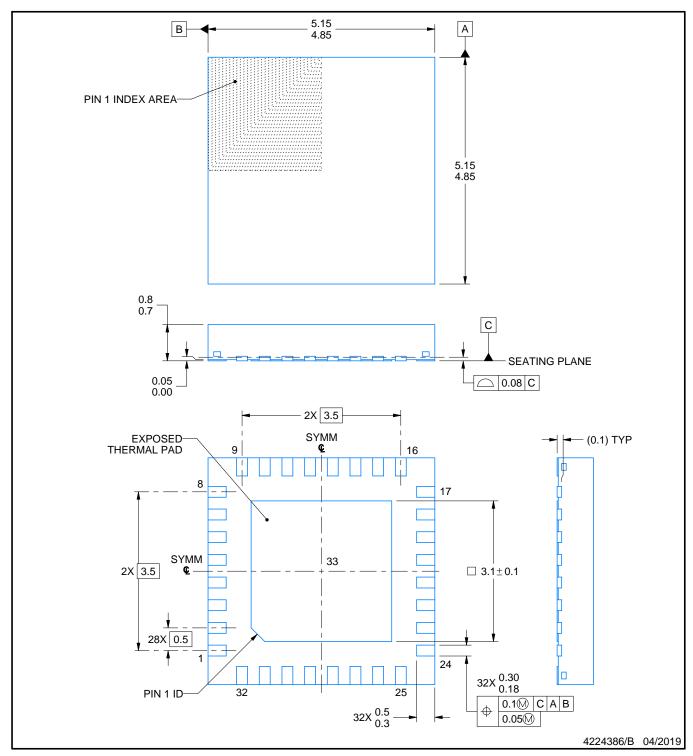


NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



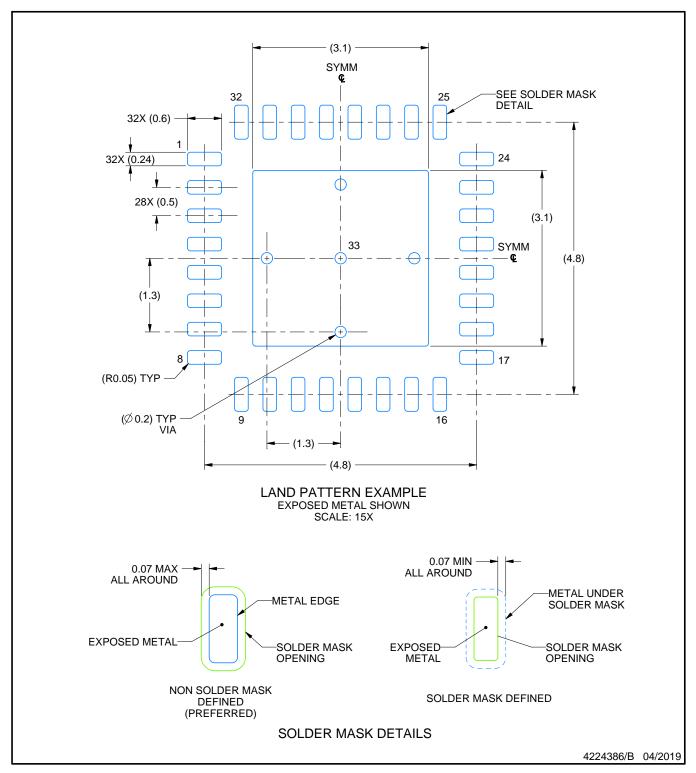




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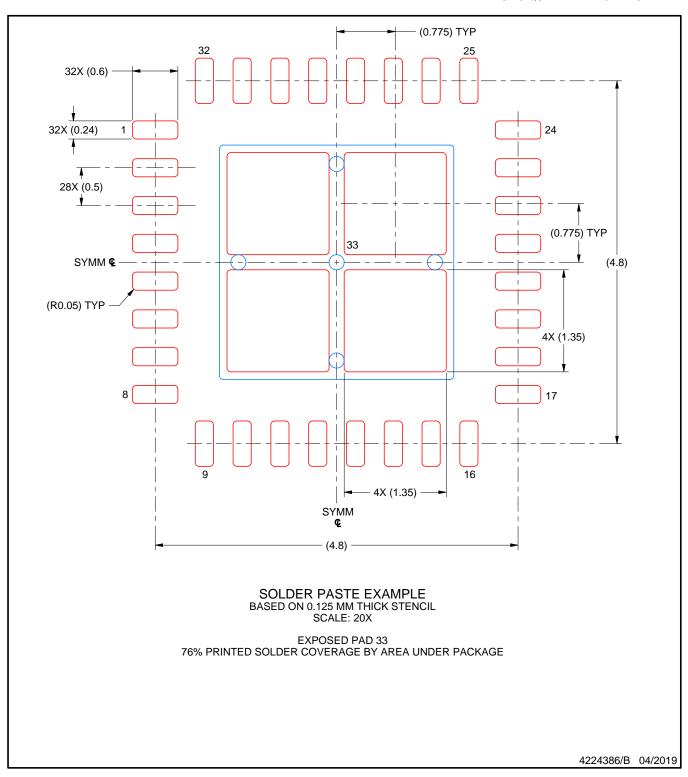




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